

CE EMC Test Report

Report No.: CE190218C25

Test Model: RCX-1422R

Series Model: RCX-1XXXXXXXXXXXXXXXXXXXXXXXXXXXX ("X" can be 0-9, A-Z or blank for marketing purpose)

Received Date: Feb. 18, 2019

Test Date: Mar. 26, 2019 ~ Apr. 12, 2019

Issued Date: Apr. 18, 2019

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Table of Contents

Release Control Record	5
1 Certificate of Conformity	6
2 Summary of Test Results	7
2.1 Measurement Uncertainty	8
2.2 Modification Record.....	8
3 General Information	9
3.1 General Description of EUT	9
3.2 Features of EUT	9
3.3 Operating Modes of EUT and Determination of Worst Case Operating Mode	10
3.4 Test Program Used and Operation Descriptions.....	10
3.5 Primary Clock Frequencies of Internal Source.....	11
3.6 Miscellaneous.....	11
4 Configuration and Connections with EUT.....	12
4.1 Connection Diagram of EUT and Peripheral Devices	12
4.2 Configuration of Peripheral Devices and Cable Connections	13
5 Conducted Disturbance at Mains Ports.....	15
5.1 Limits	15
5.2 Test Instruments	15
5.3 Test Arrangement	16
5.4 Test Results	17
6 Asymmetric Mode Conducted Emission at Wired Network Ports	21
6.1 Limits	21
6.2 Test Instruments	21
6.3 Test Arrangement	23
6.4 Test Results	26
7 Radiated Disturbance up to 1 GHz	27
7.1 Limits	27
7.2 Test Instruments	27
7.3 Test Arrangement	28
7.4 Test Results	29
8 Radiated Disturbance above 1 GHz	31
8.1 Limits	31
8.2 Test Instruments	32
8.3 Test Arrangement	33
8.4 Test Results	34
9 Harmonics Current Measurement	36
9.1 Limits	36
9.2 Classification of Equipment.....	36
9.3 Test Instruments	37
9.4 Test Arrangement	37
9.5 Test Results	38
10 Voltage Fluctuations and Flicker Measurement	40
10.1 Limits	40
10.2 Test Instruments	40
10.3 Test Arrangement	40
10.4 Test Results	41

11	General Immunity Requirements	42
11.1	Specific Immunity Requirements by Manufacturer	43
11.2	Performance Criteria	43
	General Performance Criteria	43
	Product Specific Performance Criteria	44
12	Electrostatic Discharge Immunity Test (ESD).....	45
12.1	Test Specification	45
12.2	Test Instruments	45
12.3	Test Arrangement	45
12.4	Test Results	47
13	Radiated, Radio-frequency, Electromagnetic Field Immunity Test (RS)	51
13.1	Test Specification	51
13.2	Test Instruments	51
13.3	Test Arrangement	52
13.4	Test Results	52
14	Electrical Fast Transient/Burst Immunity Test (EFT).....	53
14.1	Test Specification	53
14.2	Test Instruments	53
14.3	Test Arrangement	54
14.4	Test Results	55
15	Surge Immunity Test.....	56
15.1	Test Specification	56
15.2	Test Instruments	56
15.3	Test Arrangement	57
15.4	Test Results	58
16	Immunity to Conducted Disturbances Induced by RF Fields (CS)	59
16.1	Test Specification	59
16.2	Test Instruments	59
16.3	Test Arrangement	60
16.4	Test Results	61
17	Power Frequency Magnetic Field Immunity Test.....	62
17.1	Test Specification	62
17.2	Test Instruments	62
17.3	Test Arrangement	62
17.4	Test Results	63
18	Voltage Dips and Interruptions.....	64
18.1	Test Specification	64
18.2	Test Instruments	64
18.3	Test Arrangement	64
18.4	Test Results	65
19	Pictures of Test Arrangements	66
19.1	Conducted Disturbance at Mains Ports.....	66
19.2	Asymmetric Mode Conducted Emission at Wired Network Ports	67
19.3	Radiated Disturbance up to 1 GHz	68
19.4	Radiated Disturbance above 1 GHz.....	69
19.5	Harmonics Current, Voltage Fluctuations and Flicker Measurement.....	70
19.6	Electrostatic Discharge Immunity Test (ESD)	70
19.7	Radio-frequency, Electromagnetic Field Immunity Test (RS).....	71
19.8	Electrical Fast Transient/Burst Immunity Test (EFT)	73

19.9	Surge Immunity Test.....	74
19.10	Conducted Disturbances Induced by RF Fields (CS)	75
19.11	Power Frequency Magnetic Field Immunity Test (PFMF)	76
19.12	Voltage Dips and Interruptions	76
Appendix – Information of the Testing Laboratories		77

Release Control Record

Issue No.	Description	Date Issued
CE190218C25	Original Release	Apr. 18, 2019

1 Certificate of Conformity

Product: Expandable Fanless System
Brand: Vecow
Test Model: RCX-1422R
Series Model: RCX-1XXXXXXXXXXXXXXXXXXXXXXXXX ("X" can be 0-9, A-Z or blank for marketing purpose)
Sample Status: Mass product
Applicant: Vecow Co., Ltd.
Test Date: Mar. 26, 2019 ~ Apr. 12, 2019
Standards: **EN 55032:2015 +AC:2016, Class A**
EN 61000-3-2:2014, Class A
EN 61000-3-3:2013
EN 55024:2010
EN 55024:2010 +A1:2015
EN 61000-4-2:2009 / IEC 61000-4-2:2008 ED.2.0
EN 61000-4-3:2006 +A1:2008 +A2:2010 / IEC 61000-4-3:2010 ED. 3.2
EN 61000-4-4:2012 / IEC 61000-4-4:2012 ED. 3.0
EN 61000-4-5:2014 +A1:2017 / IEC 61000-4-5:2014 +A1:2017 ED. 3.0
EN 61000-4-6:2014 +AC:2015 / IEC 61000-4-6:2013 ED.4.0
EN 61000-4-8:2010 / IEC 61000-4-8:2009 ED. 2.0
EN 61000-4-11:2004 +A1:2017 / IEC 61000-4-11:2004 +A1:2017 ED. 2.0

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

Prepared by :  , Date: Apr. 18, 2019
Lena Wang / Specialist

Approved by :  , Date: Apr. 18, 2019
Carl Chen / Project Engineer

2 Summary of Test Results

Emission				
Standard	Clause	Test Item	Result/Remarks	Verdict
EN 55032:2015 +AC:2016	A.3	Mains terminal disturbance voltage	Minimum passing Class A margin is -16.01 dB at 2.56875 MHz	Pass
EN 55032:2015 +AC:2016	A.3	Asymmetric mode conducted emission at wired network ports	Minimum passing Class A margin is -18.80 dB at 0.50751 MHz	Pass
EN 55032:2015 +AC:2016	A.2	Radiated disturbance 30-1000 MHz	Minimum passing Class A margin is -3.02 dB at 57.74 MHz	Pass
EN 55032:2015 +AC:2016	A.2	Radiated disturbance above 1 GHz	Minimum passing Class A margin is -3.10 dB at 1485.00 MHz	Pass
EN 61000-3-2:2014	-	Harmonic current emissions	Class A	Pass
EN 61000-3-3:2013	-	Voltage fluctuations and flicker	$P_{st} \leq 1.0$ $d_{max} \leq 4 \%$ $P_{It} \leq 0.65$ $d_c \leq 3.3 \%$ $T_{max} \leq 500 \text{ ms}$	Pass

Immunity				
EN 55024 Clause	Basic standard	Test Item	Result/Remarks	Verdict
4.2.1	EN 61000-4-2:2009 / IEC 61000-4-2:2008 ED. 2.0	Electrostatic discharges (ESD)	Performance Criterion B	Pass
4.2.3.2	EN 61000-4-3:2006 +A1:2008 +A2:2010 / IEC 61000-4-3:2010 ED. 3.2	Continuous radiated disturbances (RS)	Performance Criterion A	Pass
4.2.2	EN 61000-4-4:2012 / IEC 61000-4-4:2012 ED. 3.0	Electrical fast transients (EFT)	Performance Criterion A	Pass
4.2.5	EN 61000-4-5:2014 +A1:2017 / IEC 61000-4-5:2014 +A1:2017 ED. 3.0	Surges	Performance Criterion A	Pass
4.2.3.3	EN 61000-4-6:2014 +AC:2015 / IEC 61000-4-6:2013 ED. 4.0	Continuous conducted disturbances (CS)	Performance Criterion A	Pass
4.2.4	EN 61000-4-8:2010 / IEC 61000-4-8:2009 ED. 2.0	Power-frequency magnetic fields (PFMF)	Performance Criterion A	Pass
4.2.6	EN 61000-4-11:2004 +A1:2017 / IEC 61000-4-11:2004 +A1:2017 ED. 2.0	Voltage dips and interruptions	Voltage Dips: >95 % reduction – 0.5 period, Performance Criterion A 30 % reduction – 25 periods, Performance Criterion A Voltage Interruptions: >95 % reduction – 250 periods, Performance Criterion C	Pass

Note:

1. There is no deviation to the applied test methods and requirements covered by the scope of this report.

2. Determining compliance based on the results of the compliance measurement, not taking into account measurement instrumentation uncertainty.

2.1 Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measurement	Expanded Uncertainty (k=2) (\pm)	Maximum allowable uncertainty (\pm)
Conducted disturbance at mains port using AMN, 150 kHz ~ 30 MHz	2.44 dB	3.4 dB (U_{CISPR})
Asymmetric mode conducted emission using AAN, 150 kHz ~ 30 MHz	2.69 dB	5.0 dB (U_{CISPR})
Radiated disturbance, 30 MHz ~ 1 GHz	4.70 dB	6.3 dB (U_{CISPR})
Radiated disturbance, 1 GHz ~ 6 GHz	2.26 dB	5.2 dB (U_{CISPR})

2.2 Modification Record

There were no modifications required for compliance.

3 General Information

3.1 General Description of EUT

Product	Expandable Fanless System
Brand	Vecow
Test Model	RCX-1422R
Series Model	RCX-1XXXXXXXXXXXXXXXXXXXXXXXXXXXX ("X" can be 0-9, A-Z or blank for marketing purpose)
Status of EUT	Mass product
Operating Software	Windows 10
Power Supply Rating	24 Vdc (Adapter)
Accessory Device	Refer to Note as below
Data Cable Supplied	Refer to Note as below

Note:

1. All models are listed as below.

Brand	Model	Difference
Vecow	RCX-1422R	All models are electrically identical, different model names are for marketing purpose.
	RCX-1XXXXXXXXXXXXXXXXXXXXXXXXXXXX ("X" can be 0-9, A-Z or blank for marketing purpose)	

2. The EUT uses following accessory devices.

Product	Brand	Model	Description
Adapter	Meanwell	GST280A24-C6P	I/P: 100-240 Vac, 50/60 Hz, 4.5 A, O/P: 24 Vdc, 11.67 A, 280.08W Max. 1.2 m non-shielded cable with 1 core
CPU	Intel	I7-8700	3.2 GHz
SSD	Innodisk	3MG2-P	64G
DDR4	SLINK	J48GSH1G8QHEI	8GB

3.2 Features of EUT

The tests reported herein were performed according to the method specified by Vecow Co., Ltd., for detailed feature description, please refer to the manufacturer's specifications or user's manual.

3.3 Operating Modes of EUT and Determination of Worst Case Operating Mode

Test modes are presented in the report as below.

Mode	Test Condition
Conducted Emission	
1	LAN Link + DIO 1&2 Cable + USB with M/S + USB with K/B + USB with HDD*4 + RS232 Loop + Mic&Earphone + DP with Monitor*2 + DVI-I with Monitor + IGN Cable + Adapter
Asymmetric mode conducted emission at wired network ports test	
1	LAN Link + DIO 1&2 Cable + USB with M/S + USB with K/B + USB with HDD*4 + RS232 Loop + Mic&Earphone + DP with Monitor*2 + DVI-I with Monitor + IGN Cable + Adapter
The idle mode of conducted emission test at telecom port was pre-tested based on the worst case of link mode. Due to emissions of idle mode being very low compared to link mode, only the link mode data were presented in the test report.	
Radiated Emission	
1	LAN Link + DIO 1&2 Cable + USB with M/S + USB with K/B + USB with HDD*4 + RS232 Loop + Mic&Earphone + DP with Monitor*2 + DVI-I with Monitor + Adapter
Remark:	
1. For radiated emission test, we had pre-tested all modes at 230V/50Hz and 110V/60Hz, test mode 1 at 230V/50Hz was the worst case and only this mode was presented in the report.	

Test Mode	Test Condition
Harmonics, Flicker, ESD, RS, Surge, Dip, Magnetic tests	
1	LAN Link + DIO 1&2 Cable + USB with M/S + USB with K/B + USB with Flash*4 + RS232 Loop + Mic&Earphone + DP with Monitor*2 + DVI-I with Monitor + Adapter
EFT, CS tests	
1	LAN Link + DIO 1&2 Cable + USB with M/S + USB with K/B + USB with Flash*4 + RS232 Loop + Mic&Earphone + DP with Monitor*2 + DVI-I with Monitor + Adapter
2	LAN Link + DIO 1&2 Cable + USB with M/S + USB with K/B + USB with Flash*4 + RS232 Loop + Mic&Earphone + DP with Monitor*2 + DVI-I with Monitor + Adapter <Telecommunication Port with LAN Cable>

3.4 Test Program Used and Operation Descriptions

<Emission Tests>

- a. The EUT was charged from adapter.
- b. The EUT linked with Notebooks via LAN cables.
- c. The EUT sent audio signal to the earphone.
- d. The EUT linked with Monitors via DP and DVI cables.
- e. The EUT read and wrote data with HDDs.
- f. The EUT linked with Keyboard and Mouse via USB Cable.
- g. The EUT linked with Terminals, IGN Cables, DIO Cables and GND Cable.
- h. The EUT communicated data with the Notebooks, which acted as communication partners.

<Immunity Tests>

- a. The EUT was charged from adapter.
- b. The EUT linked with Notebooks via LAN cables.
- c. The EUT sent audio signal to the Headset.
- d. The EUT linked with Monitors via DP and DVI cables.
- e. The EUT read and wrote data with Flashes.
- f. The EUT linked with Keyboard and Mouse via USB Cable.
- g. The EUT linked with Terminals, IGN Cables, DIO Cables and GND Cable.
- h. The EUT communicated data with the Notebooks, which acted as communication partners

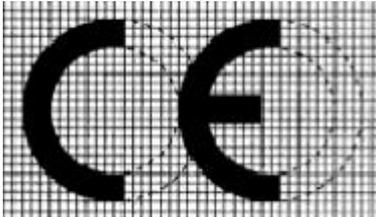
3.5 Primary Clock Frequencies of Internal Source

The highest frequency generated or used within the EUT or on which the EUT operates or tunes is 3700 MHz, provided by Vecow Co., Ltd., for detailed internal source, please refer to the manufacturer's specifications.

3.6 Miscellaneous

➤ Affix CE marking

The marking must be placed visibly and legibly on the product or, if not possible due to the nature of the product, be affixed to the packaging and the accompanying document. The CE marking shall consist of the initials 'CE' taking the following form:



The various components of the CE marking must have the same vertical dimension, and may not be smaller than 5 mm. If the CE marking is reduced or enlarged, the proportions given in the graduated drawing above must be respected.

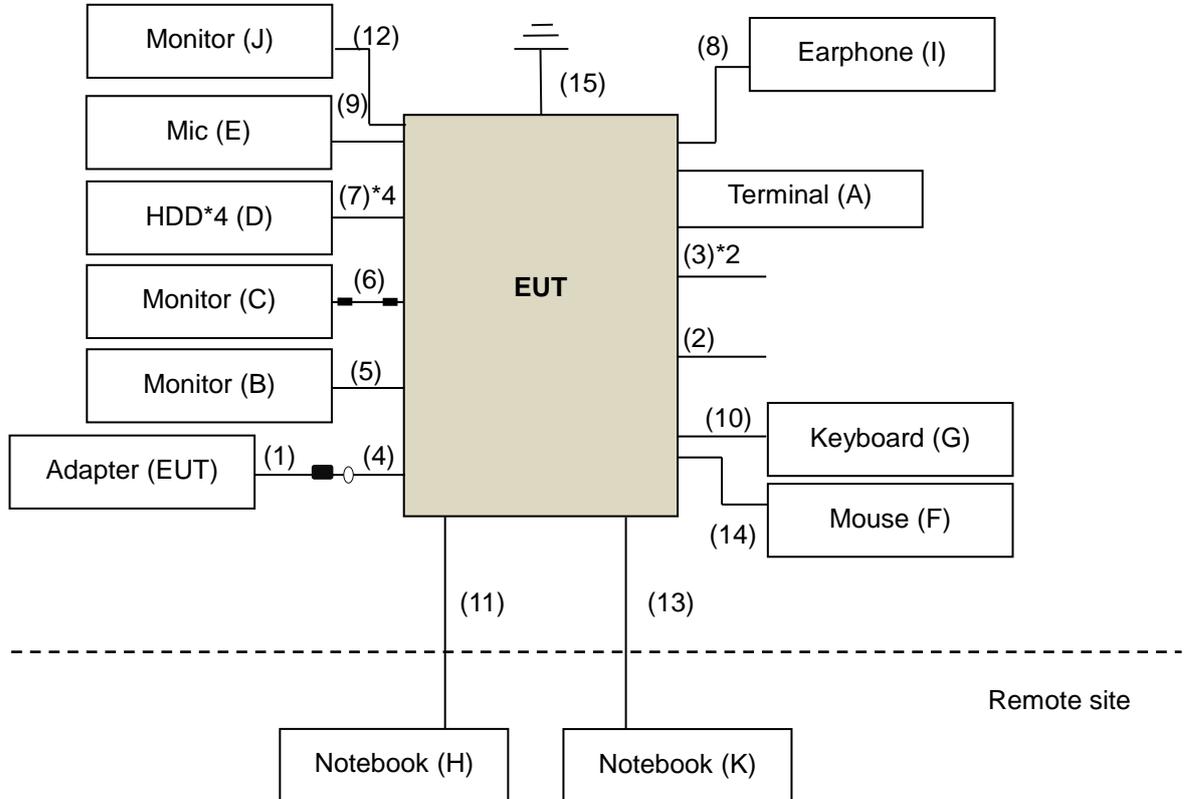
When the product is subject to other Directives covering other aspects and which also provide for the 'CE' marking, the accompanying documents must indicate that the product also conforms to those other Directives.

However, when one or more of those Directives allow the manufacturer, during a transitional period, to choose which arrangements to apply, the 'CE' marking has to indicate conformity only with the Directives applied by the manufacturer. In this case, the particularities of the Directives applied, as published in the Official Journal of the European Union, must be given in the documents, notices or instructions required by the Directives and accompanying such products.

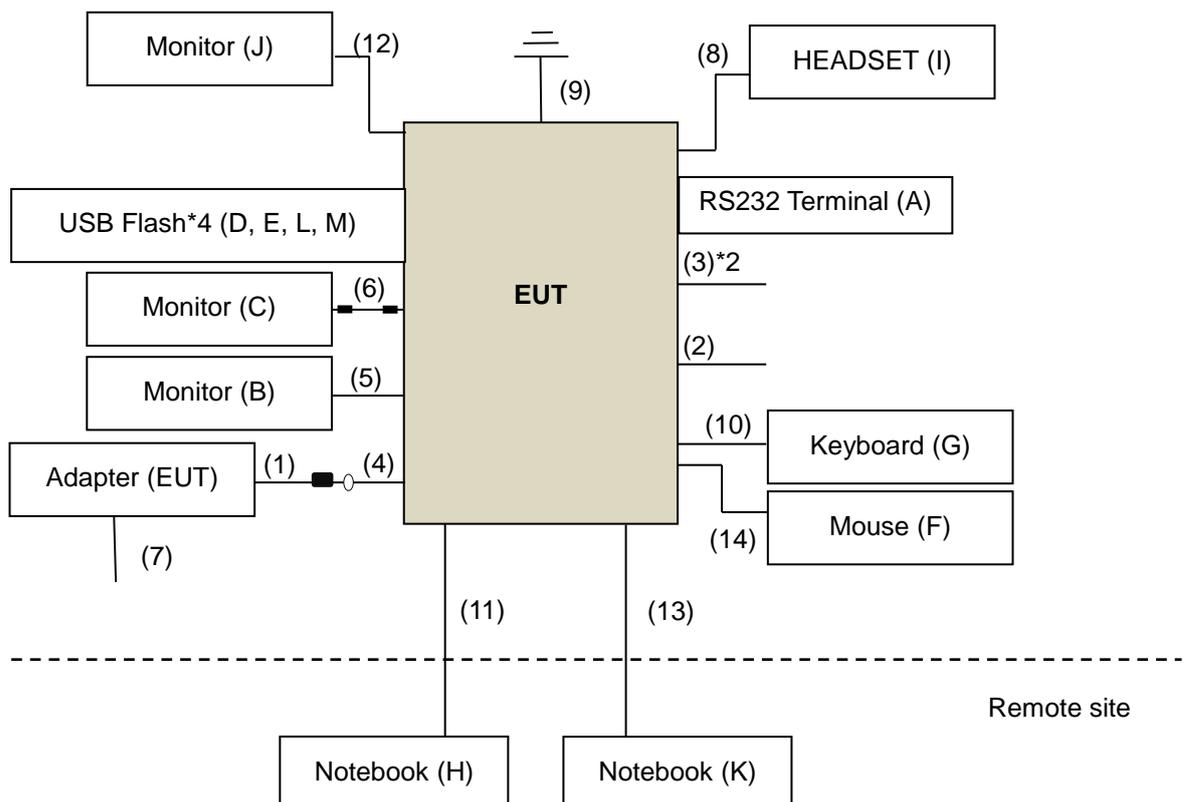
4 Configuration and Connections with EUT

4.1 Connection Diagram of EUT and Peripheral Devices

Emission tests (Harmonics & Flicker excluded):



Harmonics, Flicker, Immunity tests:



4.2 Configuration of Peripheral Devices and Cable Connections

Emission tests (Harmonics & Flicker excluded):

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
A.	Terminal	N/A	N/A	N/A	N/A	Provided by client
B.	LCD Monitor	DELL	S2817Q	CN-0GD45P-74445-6CD-012M-A01	N/A	--
C.	LCD Monitor	AOC	U2868PQU	HCXE8JA000353	ZU10019-14003	--
D.	HDD*4	Toshiba	DTB305	X4RKCMUNT3ZB	N/A	--
				X4RKCMV0T3ZB	N/A	--
				X4RKCMUMT3ZB	N/A	--
				X4RFCAMDT3ZB	N/A	--
E.	MICROPHONE	Labtec	LVA7313	N/A	N/A	--
F.	USB Mouse	DELL	MOCZUL	CN-049TWY-PRC00-79E-02FY	N/A	--
G.	USB Keyboard	DELL	KB216t	CN-0W33XP-LO300-79R-OUG8-A03	N/A	--
H.	Notebook	DELL	E6440	6QLNM32	N/A	--
I.	Earphone	Acon	CW-010M.V	N/A	N/A	--
J.	LCD Monitor	Dell	S2817Q	CN-0GD45P-74445-6CD-012M-A01	N/A	--
K.	Notebook	DELL	E6440	FMLNM32	N/A	--

Note:

1. All power cords of the above support units are non-shielded (1.8m).
2. Items H \ K acted as communication partners to transfer data.

ID	Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	DC Cable	1	1	N	1	Accessory of the EUT
2.	IGN Cable	1	1	N	0	Provided by client
3.	DIO Cable	2	0.9	N	0	Provided by client
4.	DC to DC Cable	1	0.1	N	0	--
5.	DP Cable	1	1.8	Y	0	--
6.	DVI Cable	1	1.8	Y	2	--
7.	HDD Cable	4	0.5	Y	0	--
8.	Earphone Cable	1	1.2	Y	0	--
9.	Mic. Cable	1	1.2	Y	0	--
10.	Keyboard Cable	1	1.8	Y	0	--
11.	LAN Cable	1	10	N	0	Cat5e
12.	DP Cable	1	1.8	Y	0	--
13.	LAN Cable	1	10	N	0	Cat5e
14.	Mouse Cable	1	1.8	Y	0	--
15.	GND Cable	1	1.5	N	0	--

Note: The core(s) is(are) originally attached to the cable(s).

Harmonics, Flicker, Immunity tests:

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
A.	RS232 Terminal	N/A	N/A	N/A	N/A	Provided by client
B.	Monitor	HP	Z23i	3CQ5193V8H	N/A	
C.	LCD Monitor	DELL	2408FPb	CN-0G293H-74261-874-22KS-A00	Doc	--
D.	USB Flash	Transcend	JefFlash 790	N/A	N/A	--
E.	USB Flash	Transcend	JefFlash 790	N/A	N/A	--
F.	USB Mouse	DELL	MS111-P	CN-011D3V-71581-1CJ-093M	FCC DoC Approved	--
G.	USB Keyboard	DELL	KB4021	CN-05V23T-71581-1AK-01RZ-A01	FCC DoC Approved	--
H.	Notebook	DELL	Inspiron 15 3000	JVXSD82	N/A	--
I.	HEADSET	PHILIPS	SHM2100U	01	N/A	--
J.	Monitor	HP	D7Q14A4	CNC437015W	N/A	--
K.	Notebook	DELL	Inspiron 15 3000	JBXSD82	N/A	--
L.	USB Flash	Transcend	JefFlash 790	N/A	N/A	--
M.	USB Flash	Transcend	JefFlash 790	N/A	N/A	--

Note:

1. All power cords of the above support units are non-shielded (1.8m).
2. Items H · K acted as communication partners to transfer data.

ID	Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	DC Cable	1	1	N	1	Accessory of the EUT
2.	IGN Cable	1	1	N	0	Provided by client
3.	DIO Cable	2	0.9	N	0	Provided by client
4.	DC to DC Cable	1	0.1	N	0	Provided by client
5.	DP Cable	1	1.8	Y	0	--
6.	DVI Cable	1	1.8	Y	2	--
7.	AC Cable	1	1.8	N	0	--
8.	Audio Cable	1	1.8	N	0	--
9.	GND Cable	1	2	N	0	--
10.	Keyboard Cable	1	1.8	Y	0	--
11.	LAN Cable	1	3	N	0	Cat5e
12.	DP Cable	1	1.8	Y	0	--
13.	LAN Cable	1	3	N	0	Cat5e
14.	Mouse Cable	1	1.8	Y	0	--

Note: The core(s) is(are) originally attached to the cable(s).

5 Conducted Disturbance at Mains Ports

5.1 Limits

Frequency (MHz)	Class A (dBuV)		Class B (dBuV)	
	Quasi-peak	Average	Quasi-peak	Average
0.15 - 0.5	79	66	66 - 56	56 - 46
0.50 - 5.0	73	60	56	46
5.0 - 30.0	73	60	60	50

- Notes: 1. The lower limit shall apply at the transition frequencies.
 2. The limit decreases linearly with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

5.2 Test Instruments

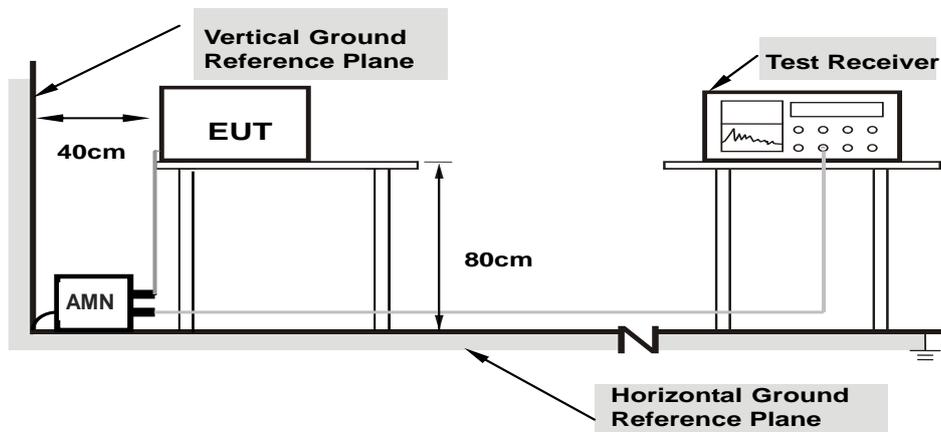
Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Test Receiver ROHDE & SCHWARZ	ESR3	102412	Feb. 14, 2019	Feb. 13, 2020
RF signal cable (with 10dB PAD) Woken	5D-FB	Cable-cond2-01	Sep. 05, 2018	Sep. 04, 2019
AMN ROHDE & SCHWARZ (EUT)	ESH2-Z5	100100	Jan. 30, 2019	Jan. 29, 2020
AMN ROHDE & SCHWARZ (Peripheral)	ESH3-Z5	100312	Aug. 13, 2018	Aug. 12, 2019
Software ADT	BV ADT_Cond_ V7.3.7.4	NA	NA	NA

- Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
 2. The test was performed in HwaYa Shielded Room 2.
 3. The VCCI Site Registration No. is C-2047.

5.3 Test Arrangement

- The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through an Artificial Mains Network (AMN). Other support units were connected to the power mains through another AMN. The two AMNs provide 50 Ohm/ 50 uH of coupling impedance for the measuring instrument.
- Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- The test results of conducted emissions at mains ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.

Note: The resolution bandwidth and video bandwidth of test receiver is 9 kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15 MHz – 30 MHz.



- Note:
- Support units were connected to second AMN.
 - The distance specified between EUT/AE and other metallic objects is ≥ 0.8 m in the measurement arrangement for table-top EUT.
 - According to EN 55032 standard, cables on the RGP must be insulated.

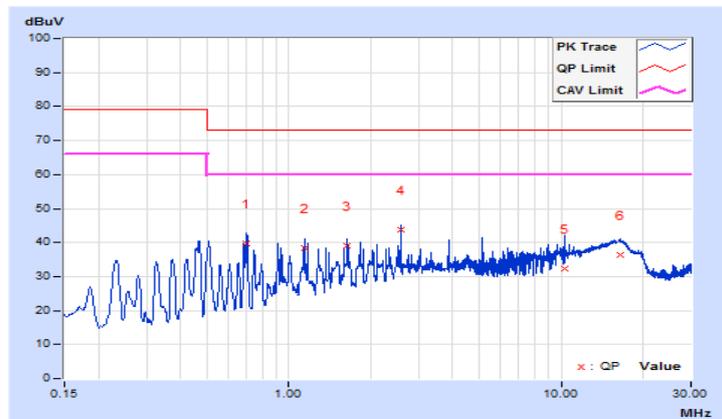
5.4 Test Results

Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz	Environmental Conditions	24°C, 72%RH
Tested by	Jim Lee	Test Date	2019/4/11
Test Mode	Mode 1		

Phase Of Power : Line (L)										
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.70125	10.08	29.71	26.83	39.79	36.91	73.00	60.00	-33.21	-23.09
2	1.14000	10.08	28.19	27.46	38.27	37.54	73.00	60.00	-34.73	-22.46
3	1.64175	10.09	28.92	27.49	39.01	37.58	73.00	60.00	-33.99	-22.42
4	2.57100	10.11	33.80	33.54	43.91	43.65	73.00	60.00	-29.09	-16.35
5	10.29075	10.28	22.13	15.21	32.41	25.49	73.00	60.00	-40.59	-34.51
6	16.53225	10.44	25.90	17.16	36.34	27.60	73.00	60.00	-36.66	-32.40

Remarks:

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value

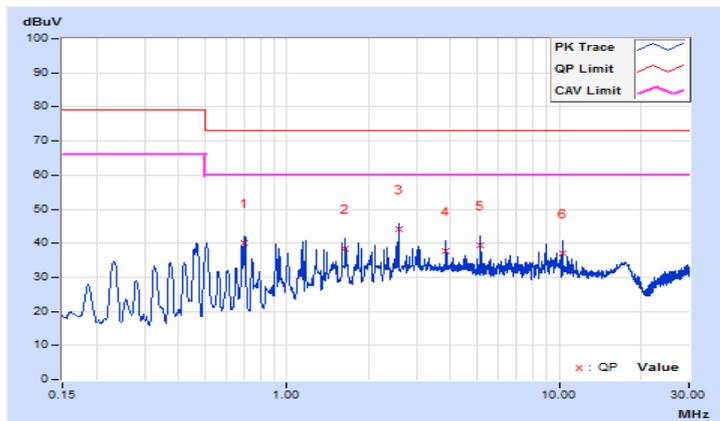


Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz	Environmental Conditions	24°C, 72%RH
Tested by	Jim Lee	Test Date	2019/4/11
Test Mode	Mode 1		

Phase Of Power : Neutral (N)										
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.70224	10.14	29.77	28.23	39.91	38.37	73.00	60.00	-33.09	-21.63
2	1.64175	10.15	28.29	26.74	38.44	36.89	73.00	60.00	-34.56	-23.11
3	2.56875	10.17	34.00	33.82	44.17	43.99	73.00	60.00	-28.83	-16.01
4	3.85350	10.21	27.61	26.68	37.82	36.89	73.00	60.00	-35.18	-23.11
5	5.13825	10.25	29.22	28.78	39.47	39.03	73.00	60.00	-33.53	-20.97
6	10.27725	10.40	26.69	23.44	37.09	33.84	73.00	60.00	-35.91	-26.16

Remarks:

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value

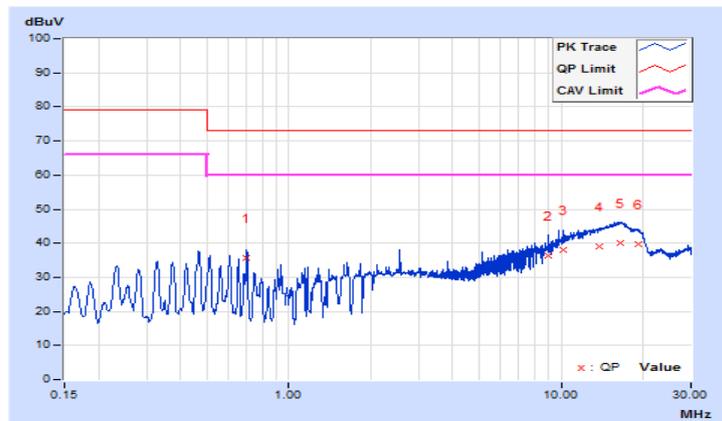


Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	110Vac, 60Hz	Environmental Conditions	24°C, 72%RH
Tested by	Jim Lee	Test Date	2019/4/11
Test Mode	Mode 1		

Phase Of Power : Line (L)										
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.70125	10.08	25.76	20.94	35.84	31.02	73.00	60.00	-37.16	-28.98
2	8.97225	10.25	25.98	20.32	36.23	30.57	73.00	60.00	-36.77	-29.43
3	10.25250	10.28	27.78	23.50	38.06	33.78	73.00	60.00	-34.94	-26.22
4	13.82775	10.37	28.68	21.68	39.05	32.05	73.00	60.00	-33.95	-27.95
5	16.44450	10.44	29.47	21.77	39.91	32.21	73.00	60.00	-33.09	-27.79
6	19.20075	10.50	29.34	21.25	39.84	31.75	73.00	60.00	-33.16	-28.25

Remarks:

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value

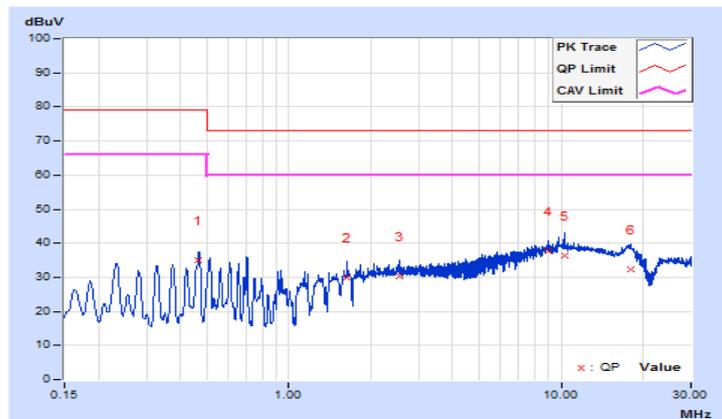


Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	110Vac, 60Hz	Environmental Conditions	24°C, 72%RH
Tested by	Jim Lee	Test Date	2019/4/11
Test Mode	Mode 1		

Phase Of Power : Neutral (N)										
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.46762	10.13	24.82	19.82	34.95	29.95	79.00	66.00	-44.05	-36.05
2	1.63950	10.15	19.91	15.01	30.06	25.16	73.00	60.00	-42.94	-34.84
3	2.56425	10.17	20.23	19.13	30.40	29.30	73.00	60.00	-42.60	-30.70
4	8.97900	10.36	27.48	23.83	37.84	34.19	73.00	60.00	-35.16	-25.81
5	10.26867	10.40	26.03	21.20	36.43	31.60	73.00	60.00	-36.57	-28.40
6	17.96325	10.63	21.69	13.78	32.32	24.41	73.00	60.00	-40.68	-35.59

Remarks:

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value



6 Asymmetric Mode Conducted Emission at Wired Network Ports

6.1 Limits

Class A					
Frequency (MHz)	Coupling Device	Voltage Limit (dBuV)		Current limits (dBuA)	
		Quasi-peak	Average	Quasi-peak	Average
0.15-0.5	AAN	97-87	84-74	-	-
0.5-30		87	74	-	-
0.15-0.5	CVP and Current probe	97-87	84-74	53-43	40-30
0.5-30		87	74	43	30
0.15-0.5	Current Probe	-	-	53-43	40-30
0.5-30		-	-	43	30
Class B					
Frequency (MHz)	Coupling Device	Voltage Limit (dBuV)		Current limits (dBuA)	
		Quasi-peak	Average	Quasi-peak	Average
0.15-0.5	AAN	84-74	74-64	-	-
0.5-30		74	64	-	-
0.15-0.5	CVP and Current probe	84-74	74-64	40-30	30-20
0.5-30		74	64	30	20
0.15-0.5	Current Probe	-	-	40-30	30-20
0.5-30		-	-	30	20

Note: The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

6.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Test Receiver ROHDE & SCHWARZ	ESCI	100424	Jan. 03, 2019	Jan. 02, 2020
RF signal cable Woken	5D-FB	Cable-cond2-01	Sep. 05, 2018	Sep. 04, 2019
AMN ROHDE & SCHWARZ (EUT)	ESH2-Z5	100100	Jan. 30, 2019	Jan. 29, 2020
AMN ROHDE & SCHWARZ (Peripheral)	ESH3-Z5	100312	Aug. 13, 2018	Aug. 12, 2019
Software ADT	BV ADT_Cond_ V7.3.7.4	NA	NA	NA
AAN	FCC-TLISN-T2-02-09	091393	Dec. 22, 2018	Dec. 21, 2019
AAN	F-071115-1057-1-09	120033	May 09, 2018	May 08, 2019
Capacitive Voltage Probe	F-CVP-1	82	Jul. 20, 2018	Jul. 19, 2019
RF Current Probe	F-33-4	45	Mar. 08, 2019	Mar. 07, 2020
Impedance-stabilization- network TESEQ	ISN ST08	41211	Aug. 17, 2018	Aug. 16, 2019
Impedance-stabilization- network TESEQ	ISN S751	40600	Aug. 17, 2018	Aug. 16, 2019

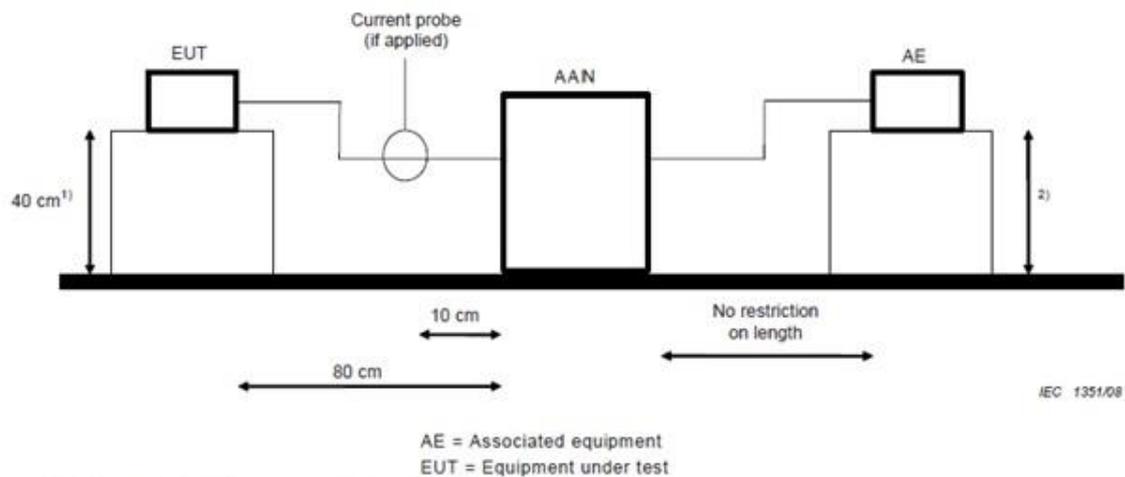
- Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The test was performed in HwaYa Shielded Room 2.
 3. The VCCI Site Registration No. is T-11654.

6.3 Test Arrangement

Method of Using AANs:

- The EUT is placed 0.4 meters from the conducting wall of the shielded room and connected to AAN directly to reference ground plane.
- If voltage measurement is used, measure voltage at the measurement port of the AAN, correct the reading by adding the AAN voltage division factor, and compare to the voltage limit.
- If current measurement is used, measure current with the current probe and compare to the current limit. A 50 Ω load has to be connected to the measurement port of the AAN during the current measurement.
- It is not necessary to apply the voltage and the current limit if a AAN is used.
- The test results of disturbance at wired network ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.

Note: The resolution bandwidth and video bandwidth of test receiver is 9 kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15 MHz – 30 MHz.

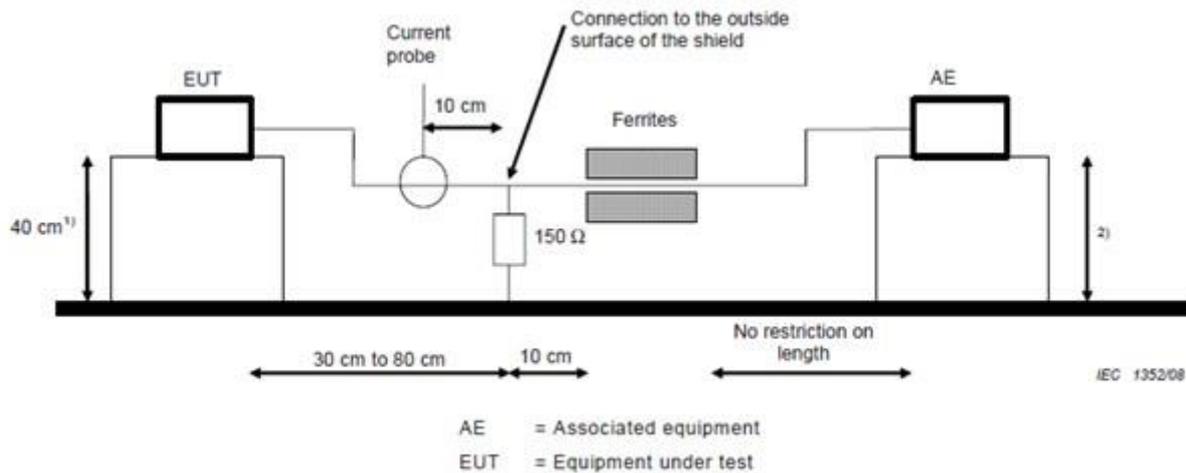


- Note:
- Distance to the reference ground plane (vertical or horizontal).
 - Distance to the reference ground plane is not critical.
 - According to EN 55032 standard, cables on the RGP must be insulated.

Method of Using a 150 Ω load to the outside surface of the shield:

- Break the insulation and connect a 150Ω resistor from the outside surface of the shield to ground.
- Apply a clamp between 150Ω connection and associated equipment.
- Current probe shall be placed at 0.1 m from the AAN.
- Measure current with a current probe and compare to the current limit.
- Voltage measurement is also possible either in parallel with the 150 Ω resistor with a high impedance probe. (only for a high impedance probe applied, replaced d. if this is the case)
- Voltage measurement by using a "50 Ω to 150 Ω adaptor" described in IEC 61000-4-6 as 150 Ω load, and applying the appropriate correction factor (9,6 dB in case of the "50 Ω to 150 Ω adaptor"). (only for 50 Ω to 150 Ω adaptor applied, replaced d. if this is the case.)
- The test results of disturbance at telecommunication ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.

Note: The resolution bandwidth and video bandwidth of test receiver is 9 kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15 MHz - 30 MHz.

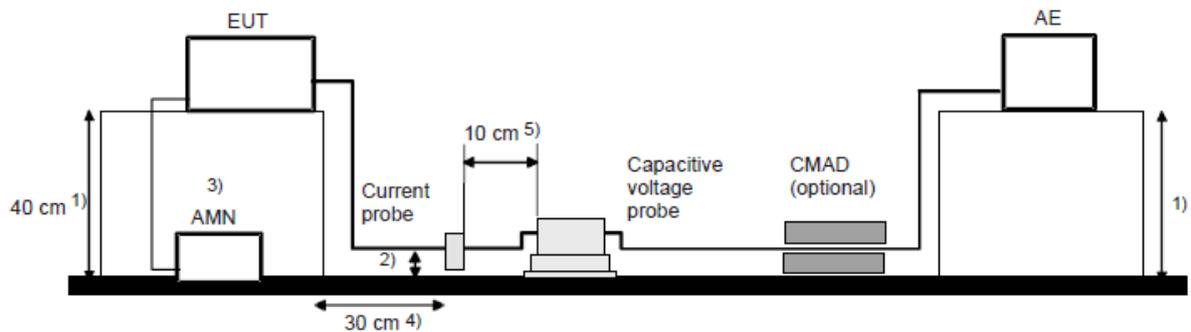


- Note:
- Distance to the reference ground plane (vertical or horizontal).
 - Distance to the reference ground plane is not critical.
 - According to EN 55032 standard, cables on the RGP must be insulated.

Method of Using a combination of current probe and capacitive voltage probe:

- a. Measure current with a current probe.
- b. Compare the measured current with the applicable current limit.
- c. Measure voltage with a capacitive probe as specified in 5.2.2 of CISPR 16-1-2.
- d. Adjust the measured voltage as follows:
 - current margin ≤ 6 dB – subtract the actual current margin from measured voltage;
 - current margin > 6 dB – subtract 6 dB from measured voltage.
- e. Compare adjusted voltage with the applicable voltage limit
- f. Both the measured current and the adjusted voltage shall be below the applicable
- g. The test results of disturbance at telecommunication ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.

Note: The resolution bandwidth and video bandwidth of test receiver is 9 kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15 MHz – 30 MHz.



IEC 1353/08

AE = Associated equipment
 EUT = Equipment under test
 CMAD = Common mode Absorbing Device

Note: 1. According to EN 55032 standard, cables on the RGP must be insulated.

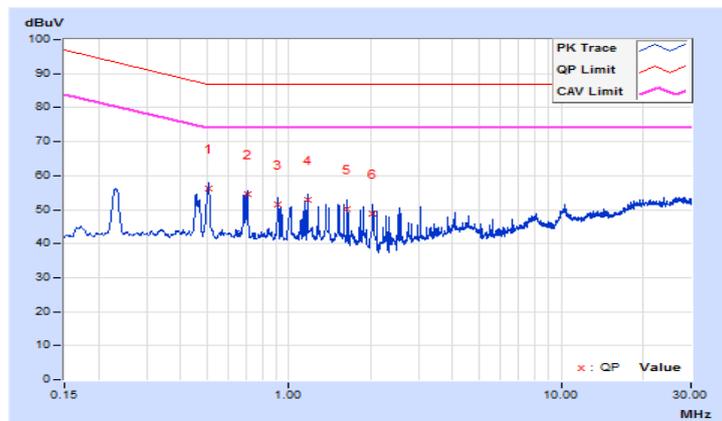
6.4 Test Results

Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz	Environmental Conditions	24°C, 72%RH
Tested by	Jim Lee	Test Date	2019/4/11
Test Mode	LAN port with ISN (1Gbps, TFGEN)		

No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.50751	9.37	46.91	45.83	56.28	55.20	87.00	74.00	-30.72	-18.80
2	0.70350	9.32	45.23	44.51	54.55	53.83	87.00	74.00	-32.45	-20.17
3	0.91203	9.27	42.17	41.04	51.44	50.31	87.00	74.00	-35.56	-23.69
4	1.17204	9.23	43.63	42.74	52.86	51.97	87.00	74.00	-34.14	-22.03
5	1.63950	9.18	40.95	40.11	50.13	49.29	87.00	74.00	-36.87	-24.71
6	2.03100	9.14	39.76	39.20	48.90	48.34	87.00	74.00	-38.10	-25.66

Remarks:

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value



7 Radiated Disturbance up to 1 GHz

7.1 Limits

Frequency (MHz)	Class A (at 10 m)	Class B (at 10 m)
	dBuV/m	dBuV/m
30 - 230	40	30
230 - 1000	47	37

Notes:

1. The lower limit shall apply at the transition frequencies.
2. Emission level (dBuV/m) = 20 log Emission level (uV/m).
3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

7.2 Test Instruments

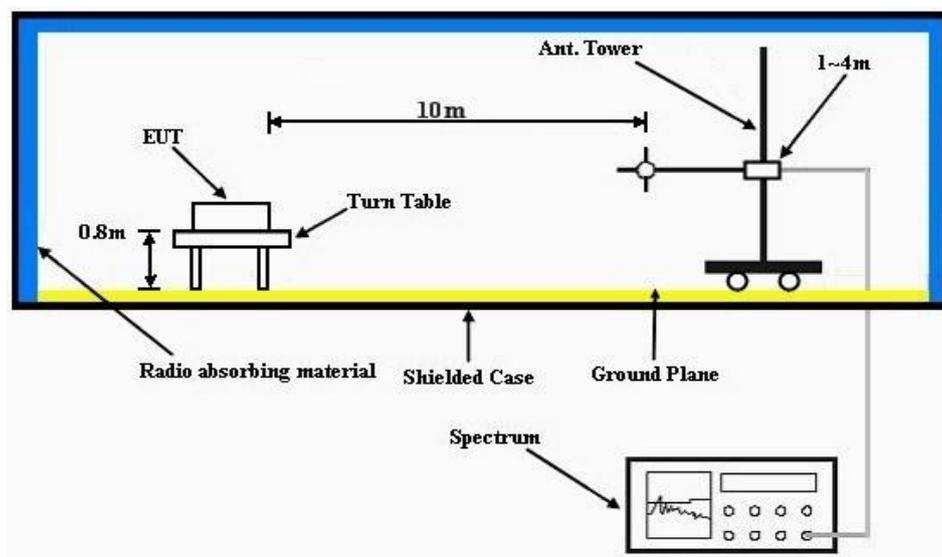
Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Test Receiver ROHDE & SCHWARZ (V)	ESR	101240	Oct. 30, 2018	Oct. 29, 2019
Test Receiver ROHDE & SCHWARZ (H)	ESR3	102412	Feb. 14, 2019	Feb. 13, 2020
BILOG Antenna SCHWARZBECK (V)	VULB9168	9168-148	Nov. 20, 2018	Nov. 19, 2019
BILOG Antenna SCHWARZBECK (H)	VULB9168	9168-156	Nov. 20, 2018	Nov. 19, 2019
Preamplifier Sonoma (V)	310N	352924	Jul. 12, 2018	Jul. 11, 2019
Preamplifier Sonoma (H)	310N	352923	Jul. 12, 2018	Jul. 11, 2019
RF signal cable (with 5dB PAD) Times (V)	LMR-600 (18M) +LMR- 400 (7M)	CABLE-CH1 (VER) -01	Oct. 03, 2018	Oct. 02, 2019
RF signal cable (with 5dB PAD) Times (H)	LMR-600 (11.8M) +LMR-400 (7M)	CABLE-CH1 (HOR) -01	Oct. 03, 2018	Oct. 02, 2019
Software BV ADT	BV ADT_Radiated_ V8.7.08	NA	NA	NA
Antenna Tower (V)	MFA-440	9707	NA	NA
Antenna Tower (H)	MFA-440	970705	NA	NA
Turn Table	DS430	50303	NA	NA
Controller (V)	MF7802	074	NA	NA
Controller (H)	MF7802	08093	NA	NA

- Notes:
1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
 2. The test was performed in HwaYa Chamber 1.
 3. The IC Site Registration No. is IC 7450F-1.
 4. The VCCI Site Registration No. is R-11893.

7.3 Test Arrangement

- The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited test facility. The table was rotated 360 degrees to determine the position of the highest radiation.
- The EUT was set 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- The antenna is a broadband antenna, and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is up to 1 GHz.

Note: The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120 kHz for quasi-peak detection (QP) at frequency up to 1 GHz.



Note: According to EN 55032 standard, cables on the RGP must be insulated.

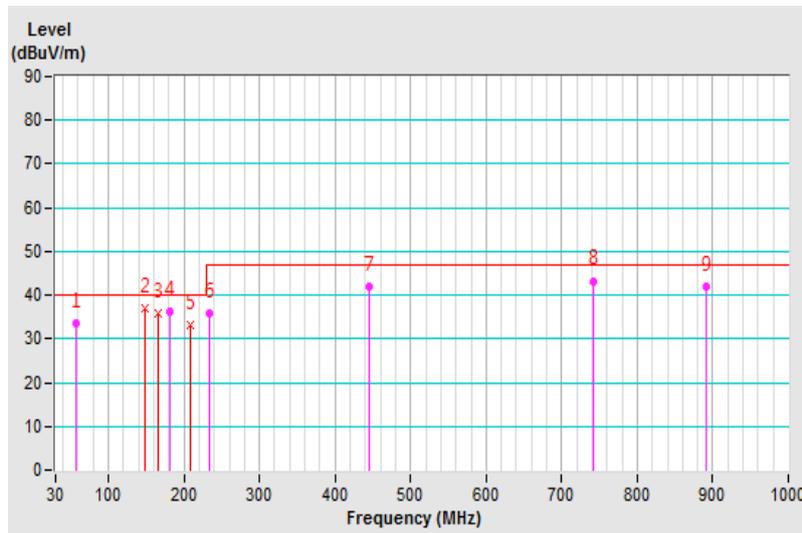
7.4 Test Results

Frequency Range	30MHz ~ 1GHz	Detector Function & Bandwidth	Quasi-Peak (QP), 120kHz
Tested by	Daniel Lin	Environmental Conditions	20°C, 60%RH
Test Mode	Mode 1	Test Date	2019/4/11

Antenna Polarity & Test Distance : Horizontal at 10 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	57.74	33.51 QP	40.00	-6.49	4.00 H	130	47.86	-14.35
2	148.49	36.90 QP	40.00	-3.10	4.00 H	158	50.57	-13.67
3	164.98	35.94 QP	40.00	-4.06	4.00 H	130	49.40	-13.46
4	181.47	36.22 QP	40.00	-3.78	4.00 H	100	50.53	-14.31
5	207.91	33.14 QP	40.00	-6.86	3.50 H	59	48.64	-15.50
6	233.32	35.83 QP	47.00	-11.17	3.50 H	209	50.81	-14.98
7	445.47	41.92 QP	47.00	-5.08	3.50 H	352	51.23	-9.31
8	742.50	43.27 QP	47.00	-3.73	4.00 H	193	46.59	-3.32
9	891.02	41.89 QP	47.00	-5.11	3.50 H	93	43.43	-1.54

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level – Limit value

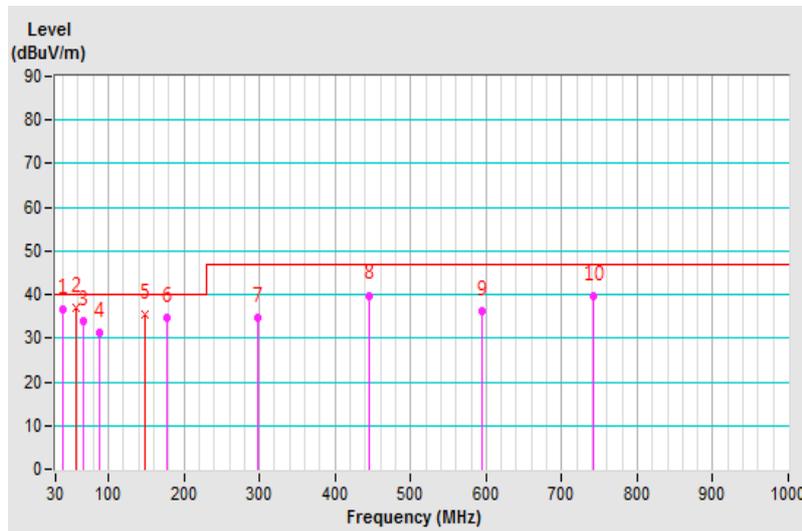


Frequency Range	30MHz ~ 1GHz	Detector Function & Bandwidth	Quasi-Peak (QP), 120kHz
Tested by	Daniel Lin	Environmental Conditions	20°C, 60%RH
Test Mode	Mode 1	Test Date	2019/4/11

Antenna Polarity & Test Distance : Vertical at 10 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	39.89	36.46 QP	40.00	-3.54	3.50 V	1	51.14	-14.68
2	57.74	36.98 QP	40.00	-3.02	3.50 V	19	51.40	-14.42
3	65.94	34.01 QP	40.00	-5.99	3.50 V	29	49.13	-15.12
4	88.93	31.22 QP	40.00	-8.78	3.50 V	41	49.51	-18.29
5	148.49	35.57 QP	40.00	-4.43	3.50 V	250	48.97	-13.40
6	178.17	34.70 QP	40.00	-5.30	4.00 V	314	48.63	-13.93
7	297.01	34.64 QP	47.00	-12.36	4.00 V	148	47.07	-12.43
8	445.47	39.83 QP	47.00	-7.17	4.00 V	329	48.90	-9.07
9	593.99	36.20 QP	47.00	-10.80	3.50 V	1	42.06	-5.86
10	742.50	39.79 QP	47.00	-7.21	3.00 V	343	42.94	-3.15

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) - Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level - Limit value



8 Radiated Disturbance above 1 GHz

8.1 Limits

Frequency (GHz)	Class A (dBuV/m) (at 3 m)		Class B (dBuV/m) (at 3 m)	
	Average	Peak	Average	Peak
1 to 3	56	76	50	70
3 to 6	60	80	54	74

Notes:

1. The lower limit shall apply at the transition frequencies.
2. Emission level (dBuV/m) = 20 log Emission level (uV/m).
3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

Frequency Range (For unintentional radiators)

Highest frequency generated or used in the EUT or on which the EUT operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Below 108	1000
108-500	2000
500-1000	5000
Above 1000	Up to 5 times of the highest frequency or 6 GHz, whichever is less

8.2 Test Instruments

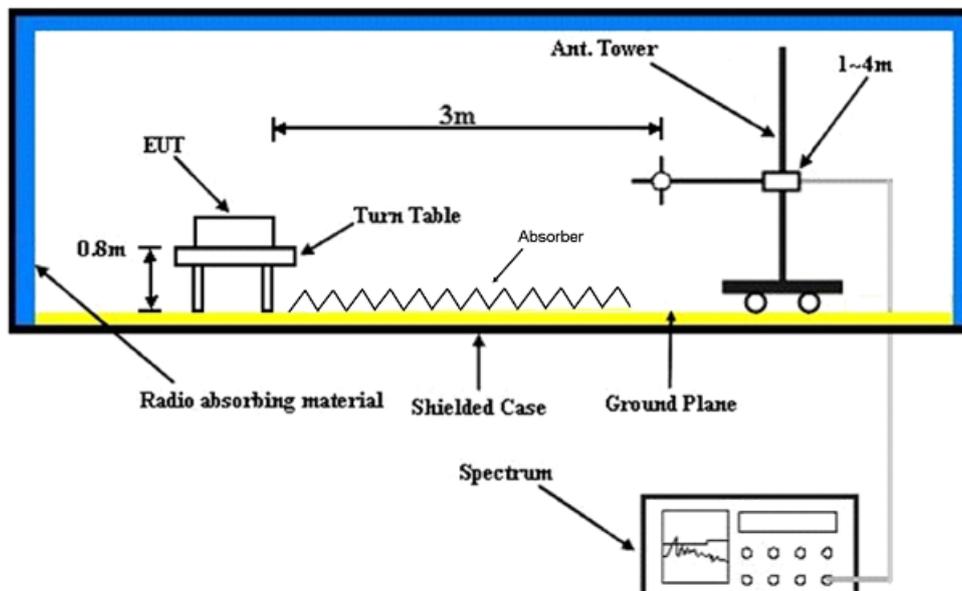
Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Test Receiver ROHDE & SCHWARZ (Above 1GHz)	ESCI	100613	Dec. 10, 2018	Dec. 09, 2019
Spectrum Analyzer Agilent	E4446A	MY51100039	Sep. 10, 2018	Sep. 09, 2019
RF signal cable (with 5dB PAD) Times	LMR-400 (18M)	CABLE-CH2-01	Apr. 27, 2018	Apr. 26, 2019
HORN Antenna (with 4dB PAD) SCHWARZBECK	BBHA 9120 D	9120D-405	Nov. 25, 2018	Nov. 24, 2019
Pre-Amplifier Agilent (Above 1GHz)	8449B	3008A01961	Oct. 15, 2018	Oct. 14, 2019
RF Coaxial Cable JUNFLON+EMC	JUNFLON+EMC104- SM-SM-6000	Cable-CH2- 02(MWX3221308G003+ 130710)	Jun. 11, 2018	Jun. 10, 2019
Software BV ADT	BV ADT_Radiated_ V8.7.08	NA	NA	NA
Antenna Tower BV ADT	AT100	AT93021702	NA	NA
Turn Table BV ADT	TT100	TT93021702	NA	NA
Controller BV ADT	SC100	SC93021702	NA	NA
RF Coaxial Cable EMCI	EMC102-KM-KM-1000	170819	Dec. 21, 2018	Dec. 20, 2019
RF Coaxial Cable Rosnol	K1K50-UP0279- K1K50-3000	181129-1	Dec. 21, 2018	Dec. 20, 2019

- Notes: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
2. The 3 dB beamwidth of the horn antenna is minimum 30 degree (or $w = 1.6$ m at 3 m distance) for 1~6 GHz.
3. The test was performed in HwaYa Chamber 2.
4. The horn antenna and HP preamplifier (model: 8449B) are used only for the measurement of emission frequency above 1GHz if tested.
5. The IC Site Registration No. is IC 7450F-2.
6. The VCCI Site Registration No. is G-10018.

8.3 Test Arrangement

- The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- The height of antenna can be varied from one meter to four meters, the height of adjustment depends on the EUT height and the antenna 3 dB beamwidth both, to detect the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- The spectrum analyzer system was set to peak and average detect function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz.

Note: The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz and video bandwidth is 3 MHz for Peak detection (PK) at frequency above 1 GHz. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz for Average detection (AV) at frequency above 1 GHz.



Note: According to EN 55032 standard, cables on the RGP must be insulated.

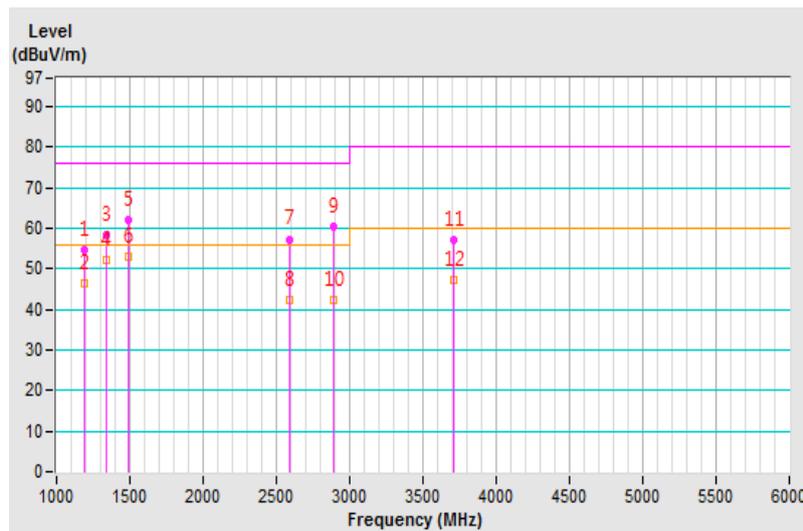
8.4 Test Results

Frequency Range	1GHz ~ 6GHz	Detector Function & Bandwidth	Peak (PK) / Average (AV), 1MHz
Tested by	Kai Chu	Environmental Conditions	22°C, 62%RH
Test Mode	Mode 1	Test Date	2019/4/12

Antenna Polarity & Test Distance : Horizontal at 3 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	1188.01	54.64 PK	76.00	-21.36	1.26 H	344	57.56	-2.92
2	1188.01	46.36 AV	56.00	-9.64	1.26 H	344	49.28	-2.92
3	1336.51	58.25 PK	76.00	-17.75	1.00 H	215	59.90	-1.65
4	1336.51	52.03 AV	56.00	-3.97	1.00 H	215	53.68	-1.65
5	1485.00	62.07 PK	76.00	-13.93	1.33 H	192	63.66	-1.59
6	1485.00	52.90 AV	56.00	-3.10	1.33 H	192	54.49	-1.59
7	2587.62	57.27 PK	76.00	-18.73	1.00 H	354	54.46	2.81
8	2587.62	42.45 AV	56.00	-13.55	1.00 H	353	39.64	2.81
9	2887.09	60.37 PK	76.00	-15.63	1.54 H	240	56.53	3.84
10	2887.09	42.31 AV	56.00	-13.69	1.54 H	240	38.47	3.84
11	3712.48	57.11 PK	80.00	-22.89	1.19 H	195	51.65	5.46
12	3712.48	47.17 AV	60.00	-12.83	1.19 H	195	41.71	5.46

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) - Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level - Limit value

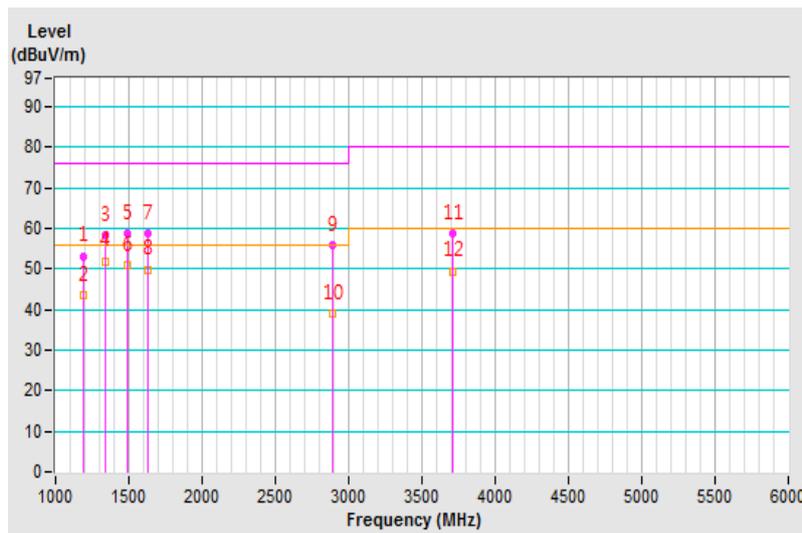


Frequency Range	1GHz ~ 6GHz	Detector Function & Bandwidth	Peak (PK) / Average (AV), 1MHz
Tested by	Kai Chu	Environmental Conditions	22°C, 62%RH
Test Mode	Mode 1	Test Date	2019/4/12

Antenna Polarity & Test Distance : Vertical at 3 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	1188.00	53.17 PK	76.00	-22.83	1.64 V	246	56.09	-2.92
2	1188.00	43.68 AV	56.00	-12.32	1.64 V	246	46.60	-2.92
3	1336.49	58.48 PK	76.00	-17.52	1.52 V	131	60.13	-1.65
4	1336.49	51.95 AV	56.00	-4.05	1.52 V	131	53.60	-1.65
5	1485.00	58.90 PK	76.00	-17.10	1.42 V	16	60.49	-1.59
6	1485.00	50.86 AV	56.00	-5.14	1.42 V	16	52.45	-1.59
7	1633.46	58.80 PK	76.00	-17.20	1.00 V	186	60.19	-1.39
8	1633.46	49.93 AV	56.00	-6.07	1.00 V	186	51.32	-1.39
9	2890.45	55.86 PK	76.00	-20.14	1.00 V	238	52.02	3.84
10	2890.45	38.86 AV	56.00	-17.14	1.00 V	238	35.02	3.84
11	3712.38	58.58 PK	80.00	-21.42	1.46 V	217	53.12	5.46
12	3712.38	49.47 AV	60.00	-10.53	1.46 V	217	44.01	5.46

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level – Limit value



9 Harmonics Current Measurement

9.1 Limits

Limits for Class A equipment		Limits for Class D equipment		
Harmonic Order n	Max. permissible harmonics current A	Harmonic Order n	Max. permissible harmonics current per watt mA/W	Max. permissible harmonics current A
Odd harmonics		Odd Harmonics only		
3	2.30	3	3.4	2.30
5	1.14	5	1.9	1.14
7	0.77	7	1.0	0.77
9	0.40	9	0.5	0.40
11	0.33	11	0.35	0.33
13	0.21	13	0.30	0.21
$15 \leq n \leq 39$	$0.15 \times 15/n$	$15 \leq n \leq 39$	$3.85/n$	$0.15 \times 15/n$
Even harmonics				
2	1.08			
4	0.43			
6	0.30			
$8 \leq n \leq 40$	$0.23 \times 8/n$			

Notes:

1. Class A and Class D are classified according to section 5 of EN 61000-3-2.
2. According to section 7 of EN 61000-3-2, the above limits for all equipment except for lighting equipment having an active input power > 75 W and no limits apply for equipment with an active input power up to and including 75 W.

9.2 Classification of Equipment

The EUT is Class A in accordance with EN 61000-3-2 as follows:

Class A	Class B	Class C	Class D
Balanced three-phase equipment, Household appliances excluding equipment as Class D, Tools excluding portable tools, Dimmers for incandescent lamps, audio equipment, equipment not specified in one of the three other classes.	Portable tools.; Arc welding equipment which is not professional equipment	Lighting equipment.	Equipment having a specified power less than or equal to 600 W of the following types: Personal computers and personal computer monitors; Television receivers; Refrigerators and freezers having one or more variable-speed drives to control compressor motor(s).

9.3 Test Instruments

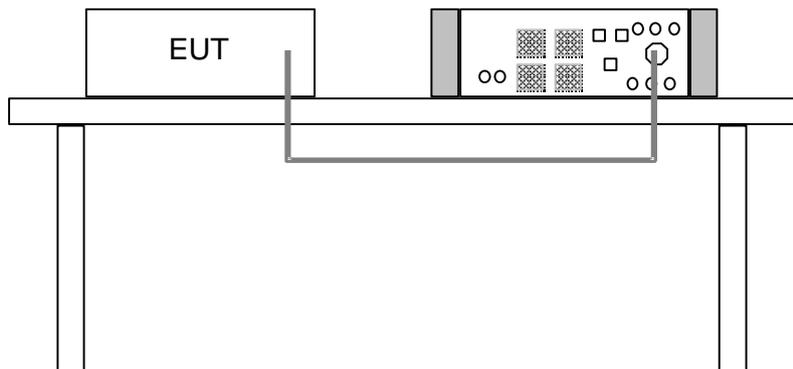
Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
TESEQ 5KVA AC POWER SOURCE/CONDITION UNIT	NSG 1007/ CCN 1000-1	1323A00070/ 1318A02119	Oct. 15, 2018	Oct. 14, 2019
Software	CTS 4 V4.19.0	NA	NA	NA

Notes: 1. The test was performed in Hwa Ya EMS Room.

2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

9.4 Test Arrangement

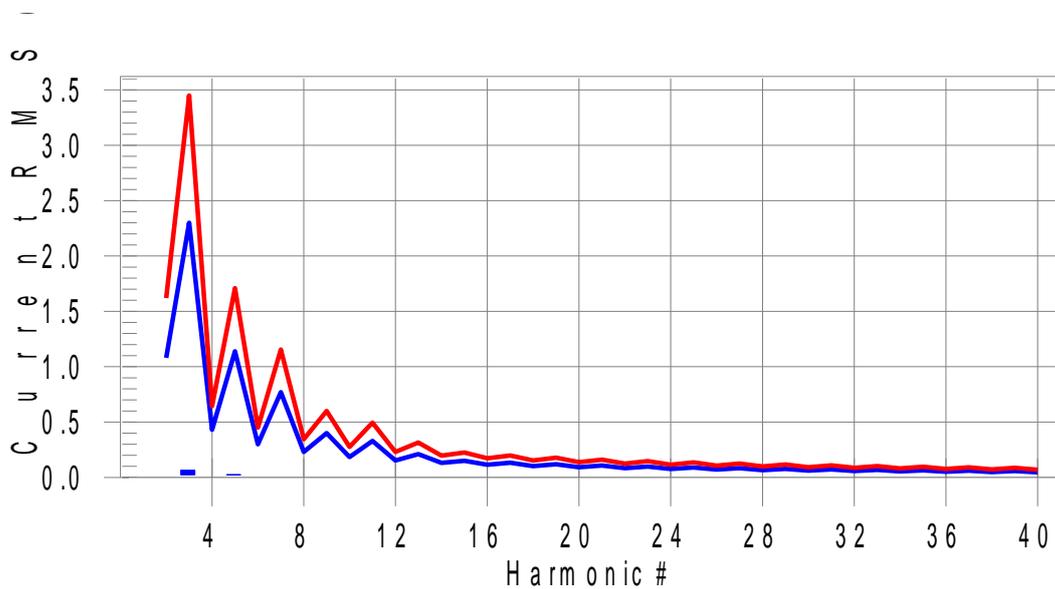
- The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.



9.5 Test Results

Test Duration (mins)	3	Tested by	Marlboro Hsu
Fundamental Voltage/Ampere	228.23 Vrms/ 0.703 Arms	Power Frequency	50 Hz
Power Consumption	139.5 W	Power Factor	0.930
Environmental Conditions	22 °C, 58 % RH	Test Date	2019/03/28
Test Mode	1		

- Note: 1. Limits are not specified for equipment with a rated power of 75 W or less (other than lighting equipment).
2. According to EN 61000-3-2 the manufacturer shall specify the power of the apparatus. This value shall be used for establishing limits. The specified power shall be within +/-10 % of the measured power.



Harm #	Harms (avg) (A)	100% Limit (A)	Harms (max) (A)	150% Limit (A)	Test Result
3	0.066	2.3	0.07	3.45	Pass
5	0.024	1.14	0.025	1.71	Pass
7	0.02	0.77	0.021	1.155	Pass
9	0.016	0.4	0.016	0.6	Pass
11	0.011	0.33	0.014	0.495	Pass
13	0.01	0.21	0.011	0.315	Pass
15	0.007	0.15	0.008	0.225	Pass
17	0.006	0.132	0.007	0.198	Pass
19	0.004	0.118	0.009	0.178	Pass
21	0.009	0.107	0.01	0.161	Pass
23	0.007	0.098	0.008	0.147	Pass
25	0.005	0.09	0.009	0.135	Pass
27	0.005	0.083	0.007	0.125	Pass
29	0.004	0.078	0.005	0.116	Pass
31	0.004	0.073	0.005	0.109	Pass
33	0.004	0.068	0.005	0.102	Pass
35	0.004	0.064	0.004	0.096	Pass
37	0.003	0.061	0.003	0.091	Pass
39	0.003	0.058	0.004	0.087	Pass

Note: Dynamic limits were applied for this test. The highest harmonics values in the above table may not occur at the same window as the maximum harmonics/limit ratio.

10 Voltage Fluctuations and Flicker Measurement

10.1 Limits

Test item	Limit	Note
P_{st}	1.0	P_{st} : short-term flicker severity.
P_{lt}	0.65	P_{lt} : long-term flicker severity.
T_{max} (ms)	500	T_{max} : maximum time duration during the observation period that the voltage deviation $d(t)$ exceeds the limit for d_c .
d_{max} (%)	4	d_{max} : maximum absolute voltage change during an observation period.
d_c (%)	3.3	d_c : maximum steady state voltage change during an observation period.

10.2 Test Instruments

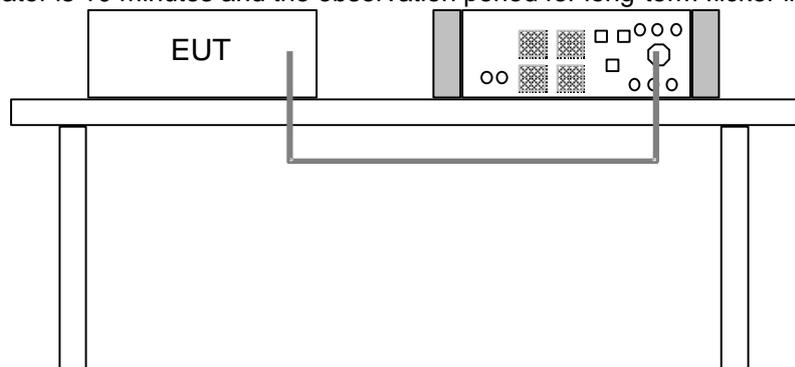
Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
TESEQ 5KVA AC POWER SOURCE/CONDITION UNIT	NSG 1007/ CCN 1000-1	1323A00070/ 1318A02119	Oct. 15, 2018	Oct. 14, 2019
Software	CTS 4 V4.19.0	NA	NA	NA

Notes: 1. The test was performed in Hwa Ya EMS Room.

2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

10.3 Test Arrangement

- The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.



10.4 Test Results

Observation (T_p)	10 min.	Tested by	Marlboro Hsu
Fundamental Voltage/Ampere	227.96 Vrms/ 0.703 Arms	Power Frequency	50 Hz
Power Consumption	139.5 W	Power Factor	0.930
Environmental Conditions	22 °C, 58 % RH	Test Date	2019/03/28
Test Mode	1		

Test Parameter	Measurement Value	Limit	Remarks
P_{st}	0.118	1.00	Pass
P_{lt}	0.052	0.65	Pass
T_{max} (ms)	0	500	Pass
d_{max} (%)	0.45	4	Pass
d_c (%)	0	3.3	Pass

- Note: (1) P_{st} means short-term flicker indicator.
 (2) P_{lt} means long-term flicker indicator.
 (3) T_{max} means accumulated time value of $d(t)$ with a deviation exceeding 3.3 %.
 (4) d_{max} means maximum relative voltage change.
 (5) d_c means maximum relative steady-state voltage change.

11 General Immunity Requirements

EN 55024:2010, Immunity requirements				
Clause	Reference standard	Table	Test specification	Performance Criterion
4.2.1	EN 61000-4-2 ESD	1.3	Enclosure port: ±8 kV Air discharge, ±4 kV Contact discharge	B
4.2.3.2	EN 61000-4-3 RS	1.2	Enclosure port: 80-1000 MHz, 3 V/m, 80% AM (1 kHz)	A
4.2.2	EN 61000-4-4 EFT	2.3	Signal ports and telecommunication ports: xDSL equipment: ±0.5 kV, 5/50 (T _r /T _h) ns, 100 kHz others: ±0.5 kV, 5/50 (T _r /T _h) ns, 5 kHz	B
		3.3	Input DC power port: ±0.5 kV, 5/50 (T _r /T _h) ns, 5 kHz	
		4.5	Input AC Power ports: ±1 kV, 5/50 (T _r /T _h) ns, 5 kHz	
4.2.5	EN 61000-4-5 Surge	2.2	Signal and telecommunication ports (direct to outdoor cables): 10/700 (5/320) (T _r /T _h) μs w/o primary protectors: ±1 kV, or with primary protectors fitted: ±4 kV	C
		3.2	Input DC power port (direct to outdoor cables): 1.2/50 (8/20) (T _r /T _h) μs Line to earth: ±0.5 kV	B
		4.4	Input AC Power ports: 1.2/50 (8/20) (T _r /T _h) μs, Line to line: ±1 kV Line to earth: ±2 kV	
4.2.3.3	EN 61000-4-6 CS	2.1	Signal and telecommunication ports (cable length > 3 m): 0.15-80 MHz, 3 V, 80 % AM (1 kHz)	A
		3.1	Input DC power port: 0.15-80 MHz, 3 V, 80 % AM (1 kHz)	
		4.1	Input AC Power ports: 0.15-80 MHz, 3 V, 80 % AM (1 kHz)	
4.2.4	EN 61000-4-8 PFMF	1.1	Enclosure port: 50 or 60 Hz, 1 A/m	A
4.2.6	EN 61000-4-11 Dips & Interruptions	4.2	Input AC Power ports: Voltage Dips: >95 % reduction – 0.5 period 30 % reduction – 25 periods	B C
		4.3	Input AC Power ports: Voltage Interruptions: >95 % reduction – 250 periods	C

11.1 Specific Immunity Requirements by Manufacturer

N/A

11.2 Performance Criteria

General Performance Criteria

Performance criterion A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Performance criterion B

After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Performance criterion C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

Product Specific Performance Criteria

The particular performance criteria which are specified in the normative annexes of EN 55024 take precedence over the corresponding parts of the general performance criteria.

Where particular performance criteria for specific functions are not given, then the general performance criteria shall apply.

Function	Performance criteria A	Performance criteria B	Performance criteria C
Read, write and storage of data	During the test storage devices shall maintain normal operation both in read/write and in standby conditions.	During and after the test failures which can be recovered by read and write retries are permissible (temporary delay in processing caused by this process is acceptable). Normal operation of the EUT shall be restored after the test, self-recovery to the conditions immediately prior to the application of the test is accepted where this is a normal means of recovery. In these cases, operator response is permitted to re-initialise an operation.	Failures during test that result in a delay in processing or a system abort, which after testing can be recovered to normal operation by reset or reboot, are permissible.
Data display	During the test, when seen from the normal viewing distance, the EUT shall operate with no change beyond the manufacturer's specification, in flicker, colour, focus and jitter (except for the power frequency magnetic field test).	Screen disturbances during the application of the test are permissible if they self-recover after removal of the external disturbance.	Failures during the test that cannot self-recover after removal of the external disturbance, but which can be recovered after the test to normal operation by reset or reboot are permissible.
Data input	During testing unintended input from an input device is not allowed. During testing input devices shall maintain the specified quality image data.	During testing keyboard/mouse "lock up" is not allowed. For EUT with manually inputted data that can be confirmed by reading the display, errors are permissible during testing if they can be recognised by the operator and easily corrected.	Failures during test that result in a delay in processing or a system abort, which after testing can be recovered to normal operation by reset or reboot, are permissible.
Data printing	During testing printers shall maintain the specified printing quality and normal operation.	During testing no degradation of the printing quality beyond the manufacturer's specification (such as distortion of character(s) or missing pixels) is permissible. A paper feed failure is allowed if after removal of the jammed sheets the job is automatically recovered and there is no loss of printed information.	During testing printing errors or omission of character(s) which require reprinting are permissible. Input/output failures that occur during testing that can be recovered to normal operation after testing by reset or reboot are also permissible.
Data processing	During testing failures which do not influence the specified operation within the product specification, and which do not prevent automatic recovery are permissible.	During testing failures which are recovered automatically but cause temporary delay in processing are permissible.	Failures during testing that - result in a delay in processing after the external disturbance is removed, but which can be recovered after testing to normal operation by a reset or reboot - result in a system abort, which can be recovered to normal operation after testing by reset or reboot, - are followed by alarms and can be recovered to normal operation by the operator's intervention after testing are permissible.

12 Electrostatic Discharge Immunity Test (ESD)

12.1 Test Specification

Basic Standard:	EN/IEC 61000-4-2
Discharge Impedance:	330 ohm / 150 pF
Discharge Voltage:	Air Discharge: $\pm 2, \pm 4, \pm 8$ kV (Direct) Contact Discharge: $\pm 2, \pm 4$ kV (Direct/Indirect)
Number of Discharge:	Air – Direct: 10 discharges per location (each polarity) Contact – Direct & Indirect: 25 discharges per location (each polarity) and min. 200 times in total
Discharge Mode:	Single Discharge
Discharge Period:	1-second minimum

12.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ELECTRONIC DISCHARGE SIMULATOR (NOISEKEN)	ESS-B3011	ESS12Z5082	Nov. 19, 2018	Nov. 18, 2019

- Notes: 1. The test was performed in Hwa Ya ESD Room 4.
2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

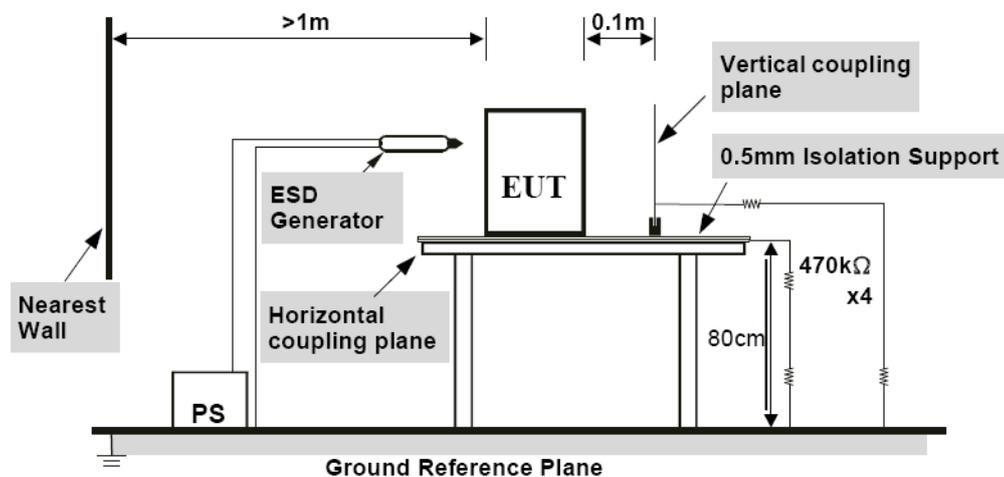
12.3 Test Arrangement

The discharges shall be applied in two ways:

- a. Contact discharges to the conductive surfaces and coupling planes:
The EUT shall be exposed to at least 200 discharges, 100 each at negative and positive polarity, at a minimum of four test points. One of the test points shall be subjected to at least 50 indirect discharges to the center of the front edge of the horizontal coupling plane. The remaining three test points shall each receive at least 50 direct contact discharges. If no direct contact test points are available, then at least 200 indirect discharges shall be applied in the indirect mode. Test shall be performed at a maximum repetition rate of one discharge per second.
- b. Air discharges at slots and apertures and insulating surfaces:
On those parts of the EUT where it is not possible to perform contact discharge testing, the equipment should be investigated to identify user accessible points where breakdown may occur. Such points are tested using the air discharge method. This investigation should be restricted to those area normally handled by the user. A minimum of 10 single air discharges shall be applied to the selected test point for each such area.

The basic test procedure was in accordance with EN/IEC 61000-4-2:

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling Plane at points on each side of the EUT. The ESD generator was positioned at a distance of 0.1 meters from the EUT with the discharge electrode touching the HCP.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5 m x 0.5 m) was placed vertically to and 0.1 meters from the EUT.



12.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Koma Kuo
Environmental Conditions	22 °C, 50 % RH 986 mbar	Test Date	2019/04/02
Test Mode	1		

Test Results of Direct Application					
Discharge Level (kV)	Polarity (+/-)	Test Point	Contact Discharge	Air Discharge	Performance Criterion
2, 4	+/-	6-9	NA	Note 1	A
8	+/-	8, 9	NA	Note 1	A
8	+/-	6, 7	NA	Note 2 & Note 3 & Note 4	B
2	+/-	1-5	Note 1	NA	A
4	+/-	1-5	Note 4	NA	B

Description of test points of direct application: Please refer to following page for representative mark only.

Test Results of Indirect Application					
Discharge Level (kV)	Polarity (+/-)	Test Point	Horizontal Coupling Plane	Vertical Coupling Plane	Performance Criterion
2, 4	+/-	Four Sides	--	Note 1	A

Description of test points of indirect application:

1. Front side 2. Rear side 3. Right side 4. Left side

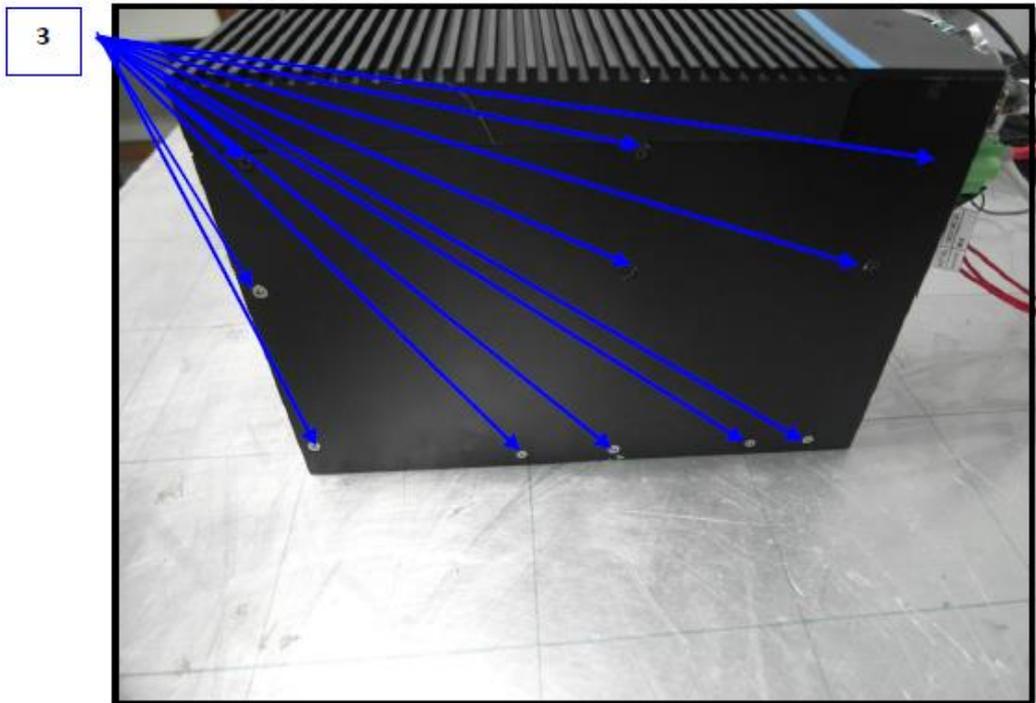
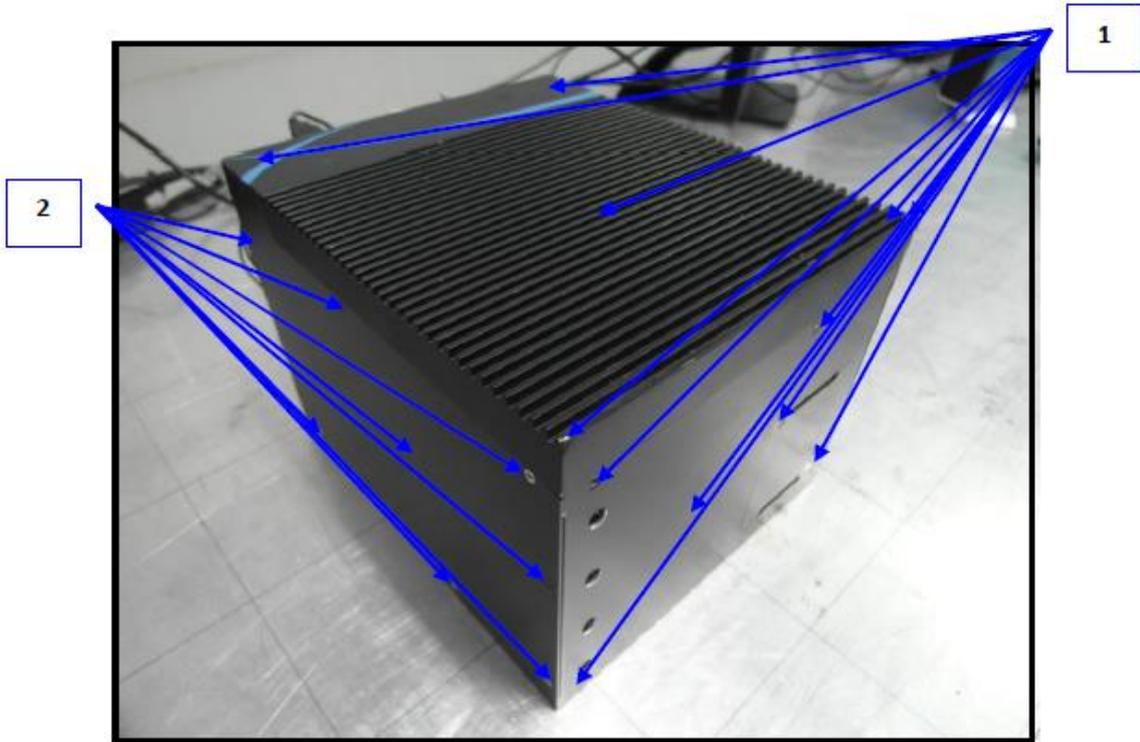
Note: 1. The EUT function was correct during the test.

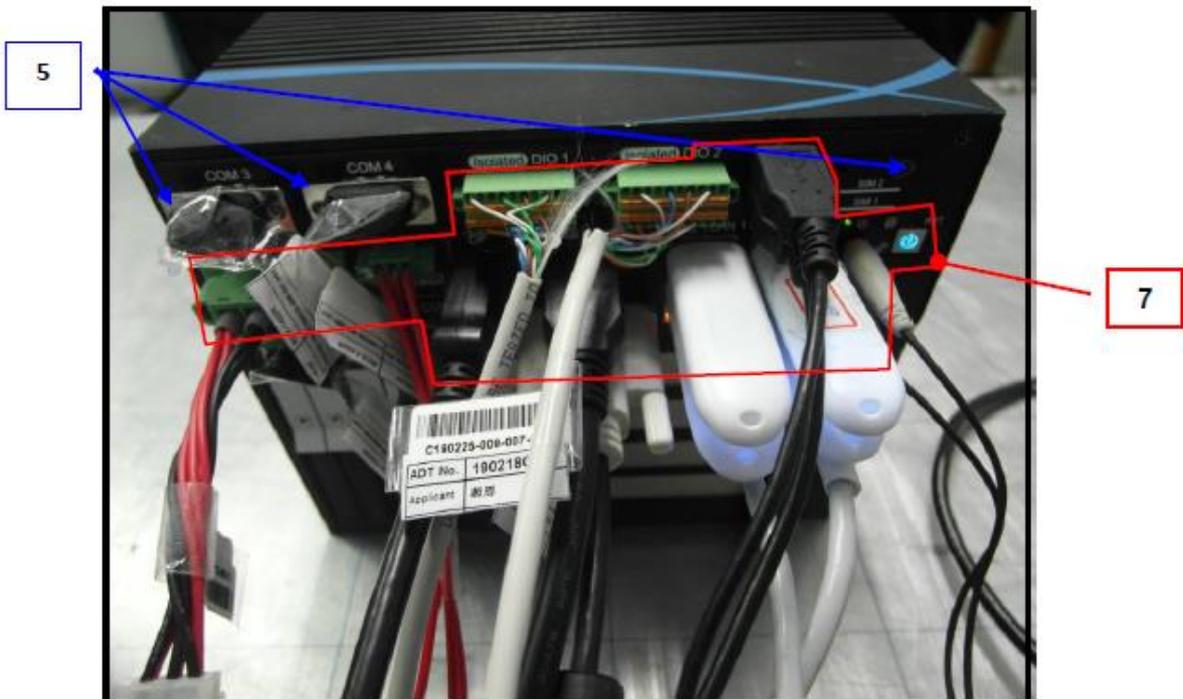
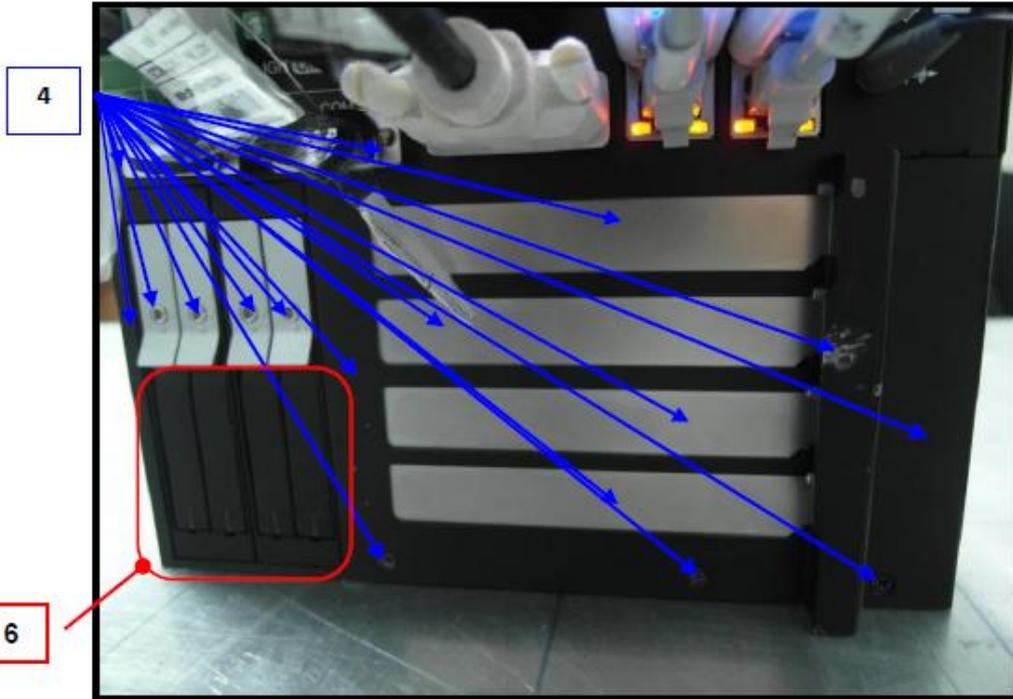
2. The HDD R/W had loss function during the test, but could self -recover to the initial operation after the test.

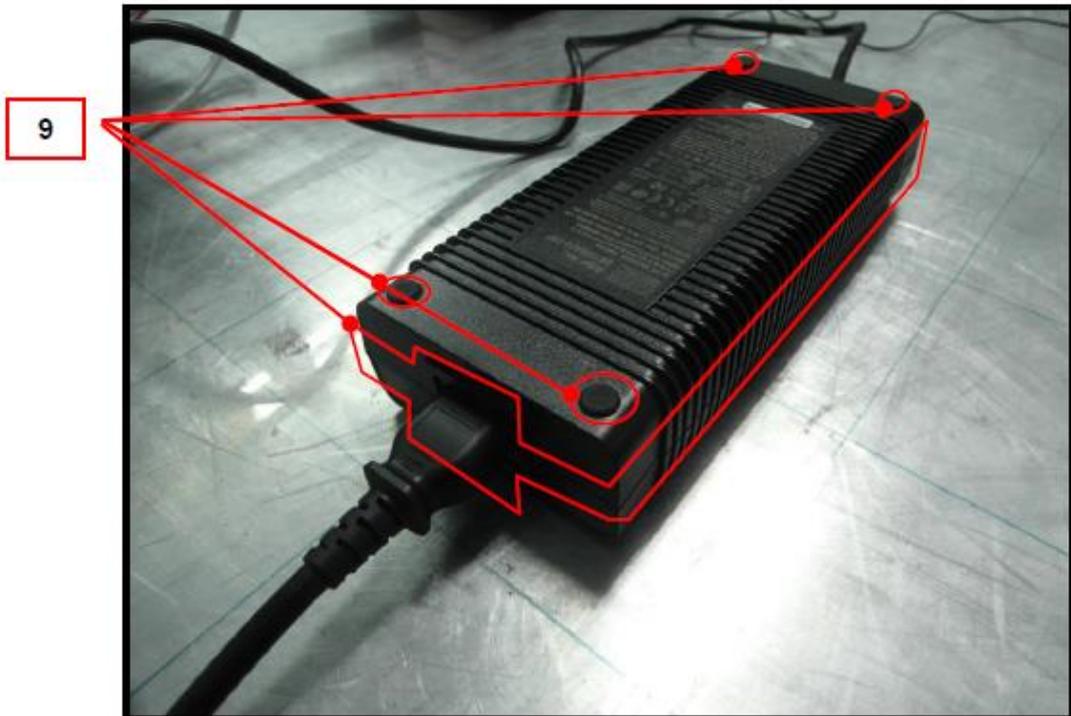
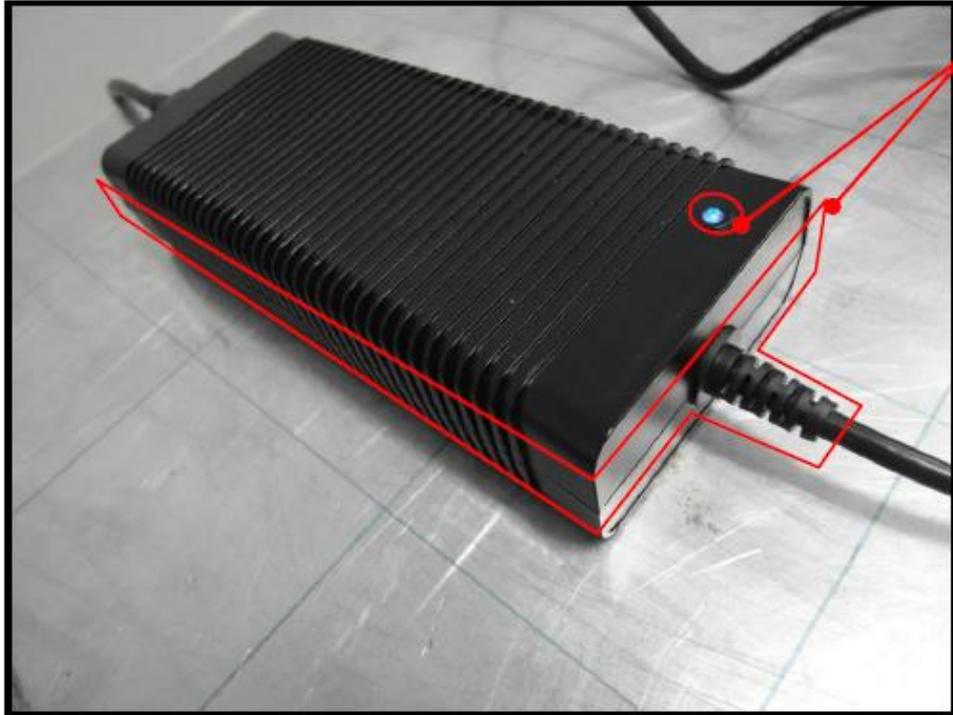
3. The EUT LAN had "request time out (Link ok) message during the test, but could self -recover to the initial operation after the test.

4. The monitor had flickered during the test, but could self -recover to the initial operation after the test.

Description of Test Points







13 Radiated, Radio-frequency, Electromagnetic Field Immunity Test (RS)

13.1 Test Specification

Basic Standard:	EN/IEC 61000-4-3
Frequency Range:	80 MHz - 1000 MHz
Field Strength:	3 V/m
Modulation:	1 kHz Sine Wave, 80 %, AM Modulation
Frequency Step:	1 % of preceding frequency value
Polarity of Antenna:	Horizontal and Vertical
Antenna Height:	1.55 m
Dwell Time:	3 seconds

13.2 Test Instruments

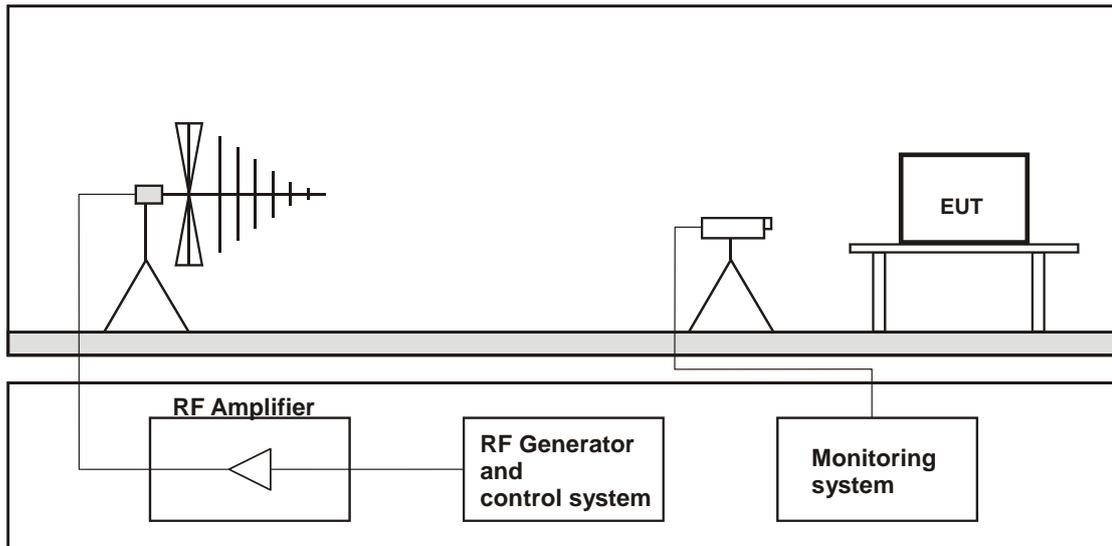
Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
BONN Power Amp	BLMA 1060-100/50D	118694	NA	NA
BBA Power Amp	B250C125	101011	NA	NA
Power Sensor	NRP-Z91	101572	Jan. 24, 2019	Jan. 23, 2020
Power Sensor	NRP-Z91	101573	Jan. 18, 2019	Jan. 17, 2020
Signal Generator	SMB100A	105801	Jan. 17, 2019	Jan. 16, 2020
R&S Software	EMC32 Version 8.52.0	NA	NA	NA
Stacked Log-Per Antenna	STLP9149	9149-141	NA	NA
High GAIN LOG-Periodic Antenna	HL046E	100114	NA	NA

- Notes:
1. The test was performed in Hwa Ya RS Room 2.
 2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
 3. The transmit antenna was located at a distance of 3 meters from the EUT.

13.3 Test Arrangement

The test procedure was in accordance with EN/IEC 61000-4-3.

- a. The testing was performed in a modified semi-anechoic chamber.
- b. The frequency range is swept from 80 MHz to 1000 MHz, with the signal 80 % amplitude modulated with a 1 kHz sine wave.
- c. The field strength level was 3 V/m.
- d. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.



13.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Evan Liao
Environmental Conditions	22 °C, 57 % RH	Test Date	2019/03/29
Test Mode	1		

Frequency (MHz)	Polarity	Azimuth(°)	Applied Field Strength		Observation	Performance Criterion
			(V/m)	Modulation		
80 -1000	V&H	0	3	80% AM (1 kHz)	Note 1	A
80 -1000	V&H	90	3	80% AM (1 kHz)	Note 1	A
80 -1000	V&H	180	3	80% AM (1 kHz)	Note 1	A
80 -1000	V&H	270	3	80% AM (1 kHz)	Note 1	A

Note: 1. The EUT function was correct during the test.

14 Electrical Fast Transient/Burst Immunity Test (EFT)

14.1 Test Specification

Basic Standard:	EN/IEC 61000-4-4
Test Voltage:	Signal / telecommunication port: ± 0.5 kV Input DC power port: N/A Input AC power port: ± 1 kV
Impulse Repetition Frequency:	xDSL telecommunication port: 100 kHz others: 5 kHz
Impulse Wave Shape:	5/50 ns
Burst Duration:	0.75 ms for 100 kHz Repetition Frequency 15 ms for 5 kHz Repetition Frequency,
Burst Period:	300 ms
Test Duration:	1 min.

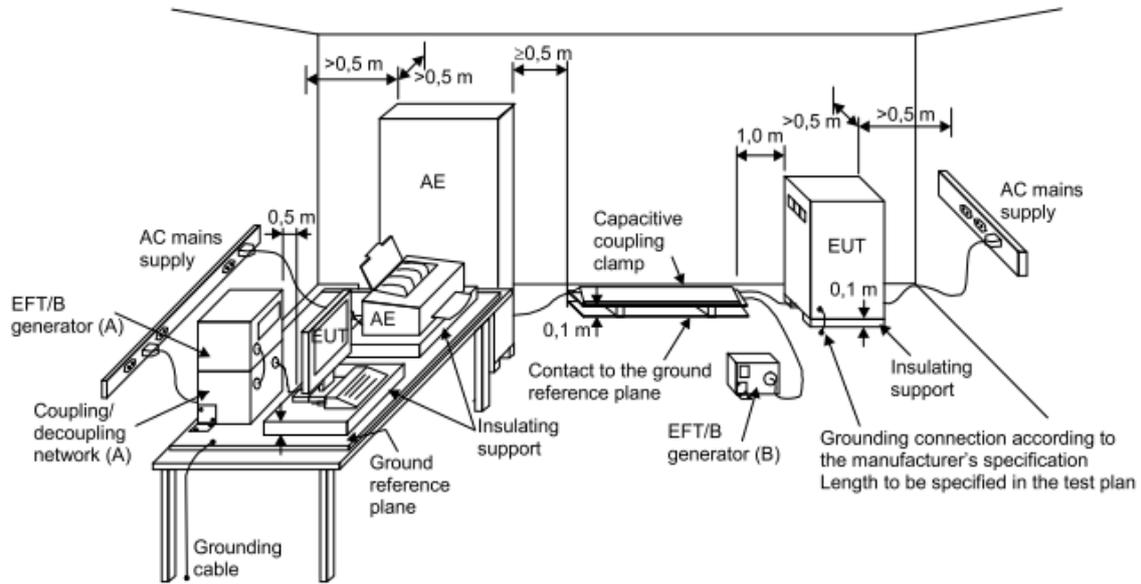
14.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
EFT Generator EMC-Partner	TRA2000 EFT-C1	623	May 11, 2018	May 10, 2019
Capacitive Coupling clamp EMC-Partner	CN-EFT1000	364	May 11, 2018	May 10, 2019
EFT Adapter WONPRO	WA	EF1Ada-001	NA	NA
Software	EMC-Partner GENECS	NA	NA	NA

- Notes: 1. The test was performed in Hwa Ya EFT Room 2.
2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

14.3 Test Arrangement

- Both positive and negative polarity discharges were applied.
- The distance between any coupling devices and the EUT should be 0.5 m for table-top equipment testing, and 1.0 m for floor standing equipment.
- The duration time of each test sequential was 1 minute.
- The transient/burst waveform was in accordance with EN/IEC 61000-4-4, 5/50 ns.



IEC 645/12

14.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Vison Tseng
Environmental Conditions	22 °C, 57 % RH	Test Date	2019/03/26
Test Mode	1		

Input DC/AC power port

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
1	L1	+/-	Note 1	A
1	L2	+/-	Note 1	A
1	PE	+/-	Note 1	A
1	L1-L2-PE	+/-	Note 1	A

Note: 1. The EUT function was correct during the test.

Input Power	230 Vac, 50 Hz	Tested by	Vison Tseng
Environmental Conditions	22 °C, 57 % RH	Test Date	2019/03/26
Test Mode	2		

Signal / telecommunication port

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
0.5	LAN	+/-	Note 1	A

Note: 1. The EUT function was correct during the test.

15 Surge Immunity Test

15.1 Test Specification

Basic Standard:	EN/IEC 61000-4-5
Wave-Shape:	Signal / telecommunication port (direct to outdoor cables*): 10/700 μ s Open Circuit Voltage 5/320 μ s Short Circuit Current Input DC power port (direct to outdoor cables*): 1.2/50 μ s Open Circuit Voltage 8/20 μ s Short Circuit Current Input AC power port: 1.2/50 μ s Open Circuit Voltage 8/20 μ s Short Circuit Current
Test Voltage:	Signal and telecommunication ports**: w/o primary protectors: N/A, with primary protectors fitted: N/A Input DC power port: Line to earth or ground: N/A Input AC power ports: Line to line: ± 1 kV, Line to earth or ground: ± 2 kV
AC Phase Angle (degree):	0°, 90°, 180°, 270°
Pulse Repetition Rate:	1 time / 60 sec.
Number of Tests:	5 positive and 5 negative at selected points

* This test is only applicable only to ports, which according to the manufacturer's specification, may connect directly to outdoor cables.

** For ports where primary protection is intended, surges are applied at voltages up to 4 kV with the primary protectors fitted. Otherwise the 1 kV test level is applied without primary protection in place.

15.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Universal Surge Coupling De-Coupling Network em test	CNV 508T5	P1508149592	Aug. 29, 2018	Aug. 28, 2019
Universal Surge Coupling De-Coupling Network TESEQ	CDN HSS-2	41008	Aug. 28, 2018	Aug. 27, 2019
Modular Impulse Generator TESEQ	NSG 3060 / CDN 3061	1796 / 1554	Oct. 15, 2018	Oct. 14, 2019
Telecom surge module TESEQ	NSG 3060	1799	Oct. 15, 2018	Oct. 14, 2019

Notes: 1. The test was performed in Hwa Ya Surge Room 1.

2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

15.3 Test Arrangement

a. Input AC/DC Power ports:

The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

For double-insulated products without PE or external earth connections, the test shall be done in a similar way as for grounded products but without adding any additional external grounded connections. If there are no other possible connections to earth, line-to-ground tests may be omitted.

b. Signal and telecommunication ports,

- Unshielded unsymmetrical interconnection lines:

The surge is applied to the lines via the capacitive coupling. The coupling / decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length.

- Unshielded symmetrical interconnections communication lines:

The surge is applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor cannot be specified. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length.

- High speed communications lines

Prior to the test, the correct operation of the port shall be verified; the external connection shall then be removed and the surge applied directly to the port's terminals with no coupling /decoupling network. After the surge, the correct operation of the port shall again be verified.

- Shielded lines:

- Direct application,

The EUT is isolated from ground and the surge is applied to its metallic enclosure; the termination (or auxiliary equipment) at the port(s) under test is grounded. This test applies to equipment with single or multiple shielded cables.

Rules for application of the surge to shielded lines:

- a) Shields grounded at both ends

- The surge injection on the shield.

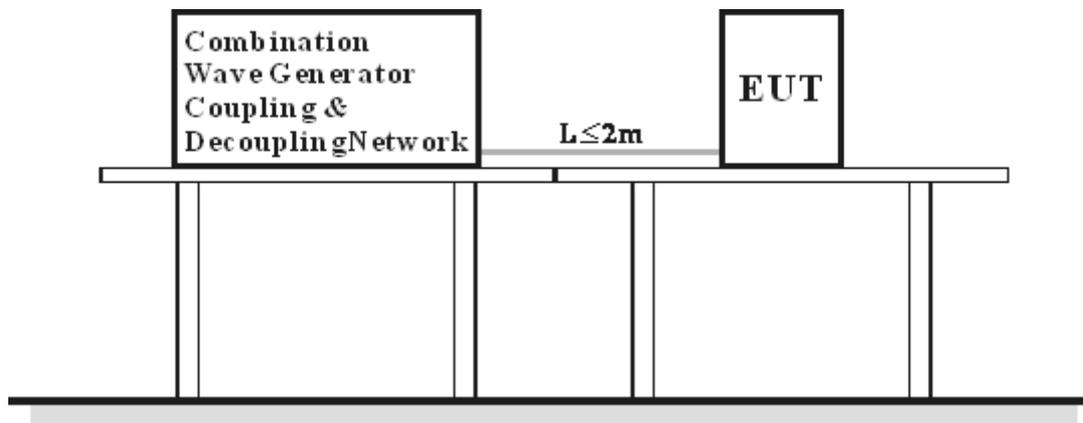
- b) Shields grounded at one end

- If in the installation the shield is connected only at the auxiliary equipment, test shall be done in that configuration but with the generator still connected to the EUT side. If cable lengths allow, the cables shall be on insulated supports 0,1 m above the ground plane or cable tray.

For products which do not have metallic enclosures, the surge is applied directly to the shielded cable.

- Alternative coupling method for testing single cables in a multi-shield configuration,

Surges are applied in close proximity to the interconnection cable under test by a wire. The length of the cable between the port(s) under test and the device attached to the other end of the cable shall be the lesser of: the maximum length permitted by the EUT's specification, or 20 m. Where the length exceeds 1 m, excess lengths of cables shall be bundled at the approximate centre of the cables with the bundles 30 cm to 40 cm in length.



15.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Andy Chang
Environmental Conditions	22 °C, 57 % RH	Test Date	2019/03/26
Test Mode	1		

Input DC/AC power port

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
0.5, 1	L1-L2	+/-	Note 1	A
0.5, 1, 2	L1-PE	+/-	Note 1	A
0.5, 1, 2	L2-PE	+/-	Note 1	A

Note: 1. The EUT function was correct during the test.

16 Immunity to Conducted Disturbances Induced by RF Fields (CS)

16.1 Test Specification

Basic Standard:	EN/IEC 61000-4-6
Frequency Range:	0.15 MHz - 80 MHz
Voltage Level:	3 V
Modulation:	1 kHz Sine Wave, 80 %, AM Modulation
Frequency Step:	1 % of preceding frequency value
Dwell Time	3 seconds

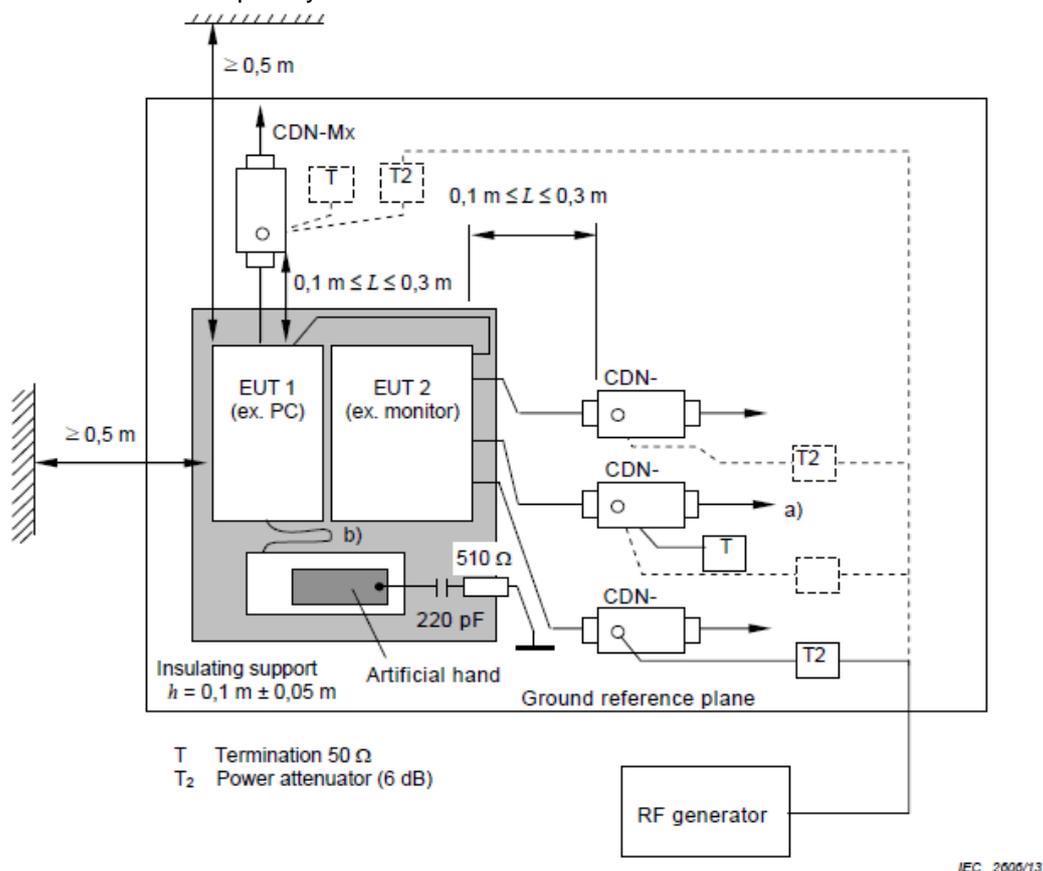
16.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
FCC POWER LINE COUPLING DECOUPLING NETWORK	FCC-801-M1-25A	03030	Jun. 15, 2018	Jun. 14, 2019
FCC POWER LINE COUPLING DECOUPLING NETWORK	FCC-801-M3-25A	03056	Nov. 05, 2018	Nov. 04, 2019
FCC SIGNAL LINE POWER LINE COUPLING DECOUPLING NETWORK	F-090407-1004-1	100923	Jun. 12, 2018	Jun. 11, 2019
Coupling Decoupling Network TESEQ	CDN T8-10	43230	Jun. 12, 2018	Jun. 11, 2019
Coupling Decoupling Network TESEQ	CDN T8-10	43229	Jun. 12, 2018	Jun. 11, 2019
EMI Injection Clamp	F203I-23MM	434	Nov. 05, 2018	Nov. 04, 2019
Amplifier Research Power Amplifier	75A250AM2	307804	NA	NA
Signal Generator ROHDE & SCHWARZ	SML01	102148	Nov. 19, 2018	Nov. 18, 2019
POWER METER BOONTON	4232A	107402	Jul. 12, 2018	Jul. 11, 2019
POWER SENSOR BOONTON	51011-EMC	33105	Jul. 12, 2018	Jul. 11, 2019
POWER SENSOR BOONTON	51011-EMC	33107	Jul. 12, 2018	Jul. 11, 2019
Software	ADT_CS_V37	NA	NA	NA

- Notes:
1. The test was performed in Hwa Ya CS Room 1.
 2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

16.3 Test Arrangement

- The EUT shall be tested within its intended operating and climatic conditions.
- An artificial hand was placed on the hand-held accessory and connected to the ground reference plane.
- One of the CDNs not used for injection was terminated with 50 ohm, providing only one return path. All other CDNs were coupled as decoupling networks.
- The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal is modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. Where the frequency is swept incrementally, the step size shall not exceed 1 % of the preceding frequency value.
- Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.



- Only one of the CDNs not used for injection shall be terminated with 50 Ω , providing only one return path. All other CDNs shall be configured as decoupling networks.
- Interconnecting cables (≤ 1 m) belonging to the EUT shall remain on the insulating support.

16.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Timothy Chen
Environmental Conditions	22 °C, 57 % RH	Test Date	2019/03/27
Test Mode	1		

Frequency (MHz)	Level (Vrms)	Tested Line	Injection Method	Return Path	Observation	Performance Criterion
0.15 – 80	3	AC Power	CDN-M3	CDN-M1	Note 1	A

Note: 1. The EUT function was correct during the test.

Input Power	230 Vac, 50 Hz	Tested by	Timothy Chen
Environmental Conditions	22 °C, 57 % RH	Test Date	2019/03/27
Test Mode	2		

Frequency (MHz)	Level (Vrms)	Tested Line	Injection Method	Return Path	Observation	Performance Criterion
0.15 – 80	3	LAN 1	CDN-T8	CDN-M1	Note 1	A

Note: 1. The EUT function was correct during the test.

17 Power Frequency Magnetic Field Immunity Test

17.1 Test Specification

Basic Standard:	EN/IEC 61000-4-8
Frequency Range:	50 Hz
Field Strength:	1 A/m
Observation Time:	1 minute
Inductance Coil:	Rectangular type, 1 m x 1 m

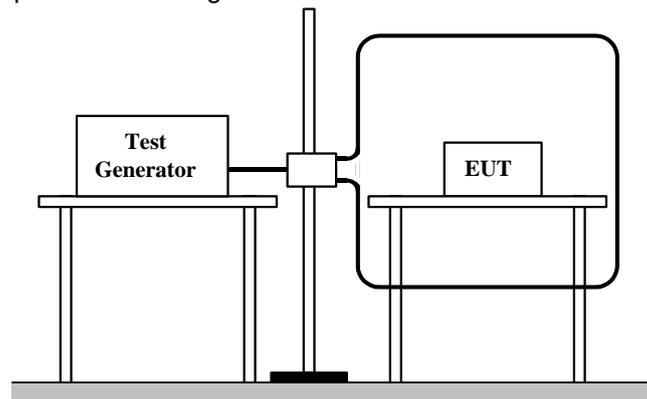
17.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
CLAMP ON AC/DC HITESTER HIOKI	3285-20	090916056	Sep. 06, 2018	Sep. 05, 2019
5KVA AC POWER SOURCE/CONDITION UNIT	NSG 1007/ CCN 1000-1	1323A00070/ 1318A02119	Oct. 15, 2018	Oct. 14, 2019
Multi turn Magnetic TESEQ	INA702/INA2141	268/1427	Oct. 15, 2018	Oct. 14, 2019

- Notes: 1. The test was performed in Hwa Ya EMS Room.
 2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

17.3 Test Arrangement

- The equipment is configured and connected to satisfy its functional requirements.
- The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.
- The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.



17.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Timothy Chen
Environmental Conditions	22 °C, 57 % RH	Test Date	2019/03/28
Test Mode	1		

Application	Frequency (Hz)	Field Strength (A/m)	Observation	Performance Criterion
X - Axis	50	1	Note 1	A
Y - Axis	50	1	Note 1	A
Z - Axis	50	1	Note 1	A

Note: 1. The EUT function was correct during the test.

18 Voltage Dips and Interruptions

18.1 Test Specification

Basic Standard:	EN/IEC 61000-4-11
Test levels:	Voltage Dips: >95 % reduction – 0.5 period 30 % reduction – 25 periods Voltage Interruptions: >95 % reduction – 250 periods
Interval between Event:	Minimum ten seconds
Sync Angle (degrees):	0° / 180°
Test Cycle:	3 times

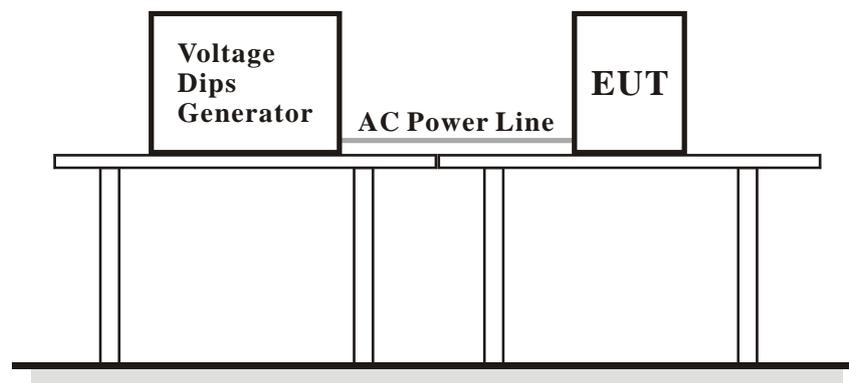
18.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
TESEQ 5KVA AC POWER SOURCE/CONDITION UNIT	NSG 1007/ CCN 1000-1	1323A00070/ 1318A02119	Oct. 15, 2018	Oct. 14, 2019
Software	Win2110 V2.2.08	NA	NA	NA

- Notes: 1. The test was performed in Hwa Ya EMS Room.
2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

18.3 Test Arrangement

The EUT shall be tested for each selected combination of test levels and duration with a sequence of 3 dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at 0 degree crossover point of the voltage waveform.



18.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Timothy Chen
Environmental conditions	22 °C, 57 % RH	Test Date	2019/03/28
Test mode	1		

Input Power for testing: 230 Vac, 50 Hz (Nominal input Voltage)					
Voltage Reduction (%)	Duration (period)	Interval (sec)	Times	Observation	Performance Criterion
>95	0.5	10	3	Note 1	A
30	25	10	3	Note 1	A
>95	250	10	3	Note 2	C

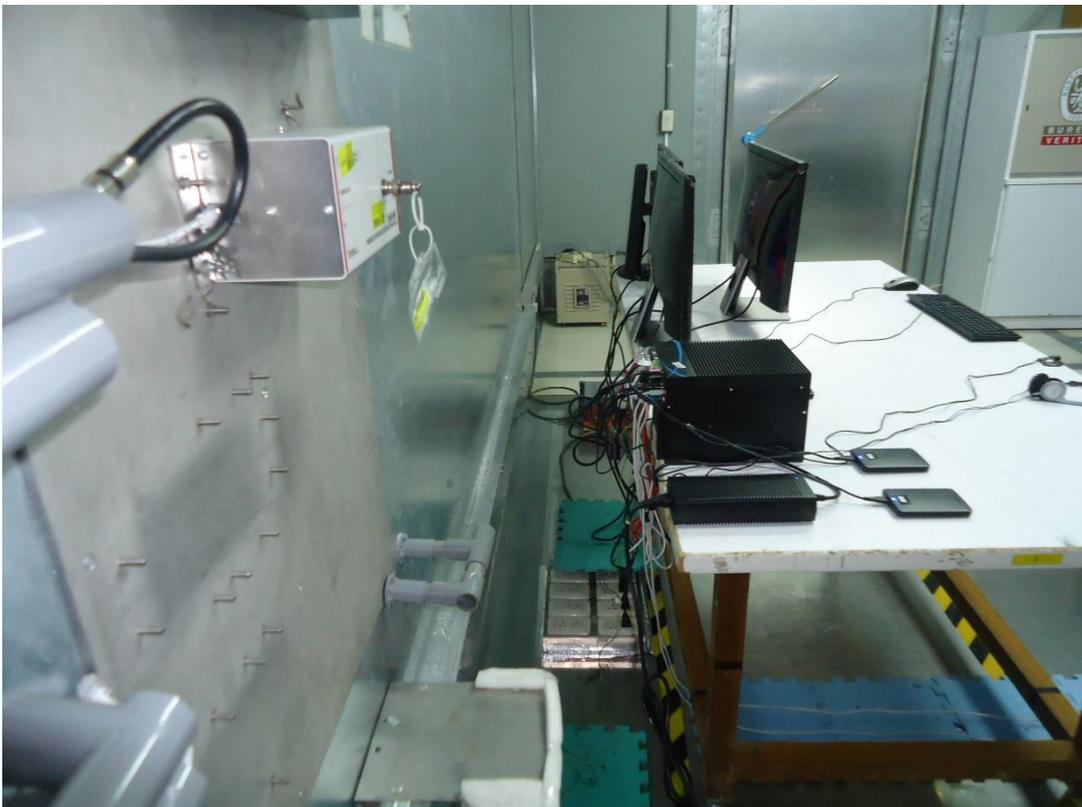
Input Power for testing: 240 Vac, 50 Hz (Maximum rated input voltage)					
Voltage Reduction (%)	Duration (period)	Interval (sec)	Times	Observation	Performance Criterion
>95	0.5	10	3	Note 1	A
30	25	10	3	Note 1	A
>95	250	10	3	Note 2	C

Input Power for testing: 100 Vac, 50 Hz (Minimum rated input voltage)					
Voltage Reduction (%)	Duration (period)	Interval (sec)	Times	Observation	Performance Criterion
>95	0.5	10	3	Note 1	A
30	25	10	3	Note 1	A
>95	250	10	3	Note 2	C

- Note: 1. The EUT function was correct during the test.
 2. The EUT shut down during the test, but must be recovered manually.

19 Pictures of Test Arrangements

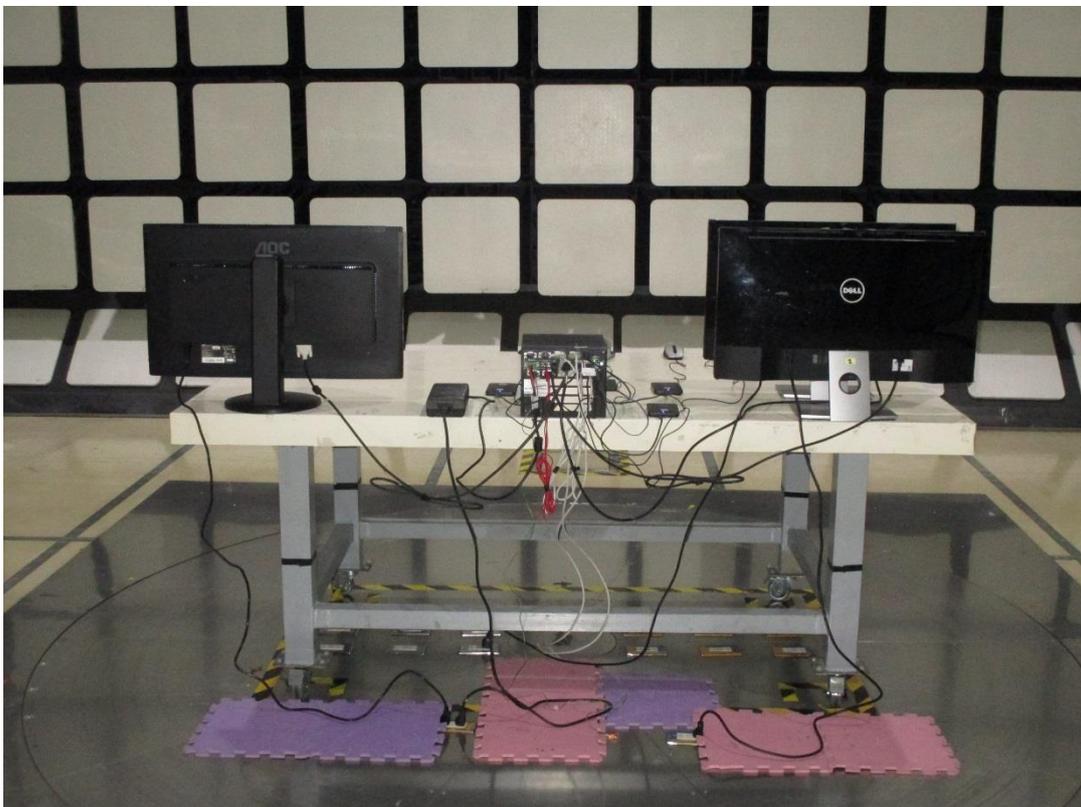
19.1 Conducted Disturbance at Mains Ports



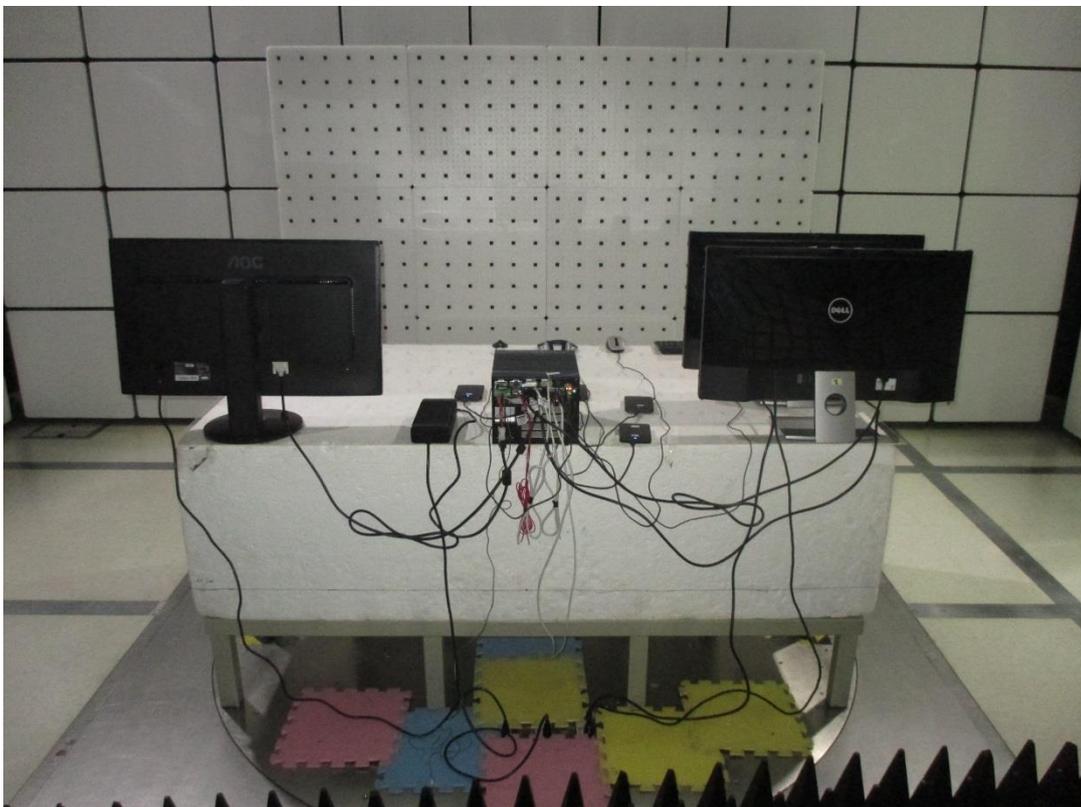
19.2 Asymmetric Mode Conducted Emission at Wired Network Ports



19.3 Radiated Disturbance up to 1 GHz



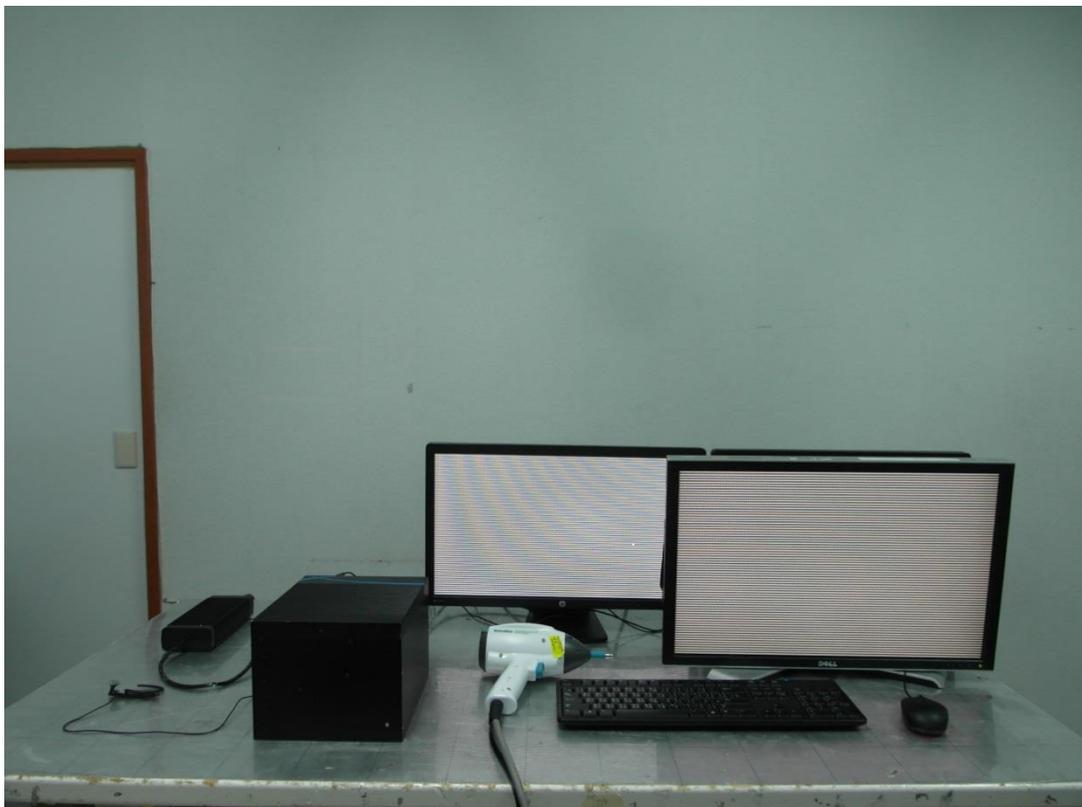
19.4 Radiated Disturbance above 1 GHz



19.5 Harmonics Current, Voltage Fluctuations and Flicker Measurement



19.6 Electrostatic Discharge Immunity Test (ESD)

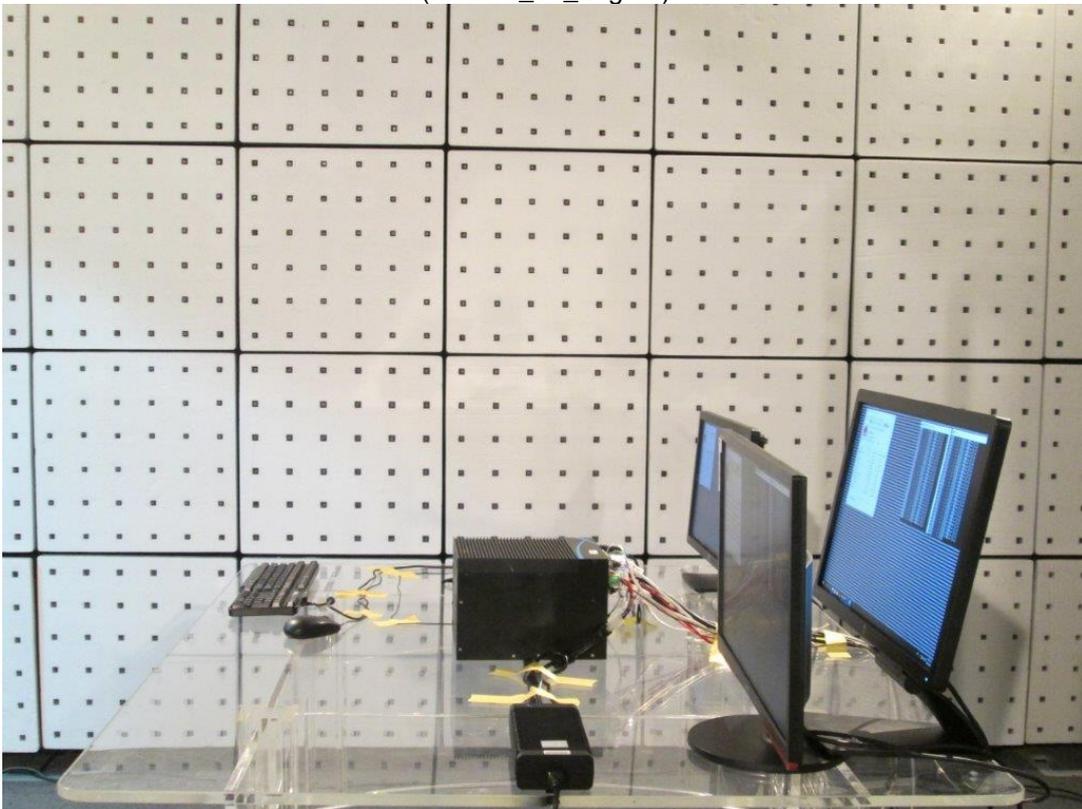


19.7 Radio-frequency, Electromagnetic Field Immunity Test (RS)

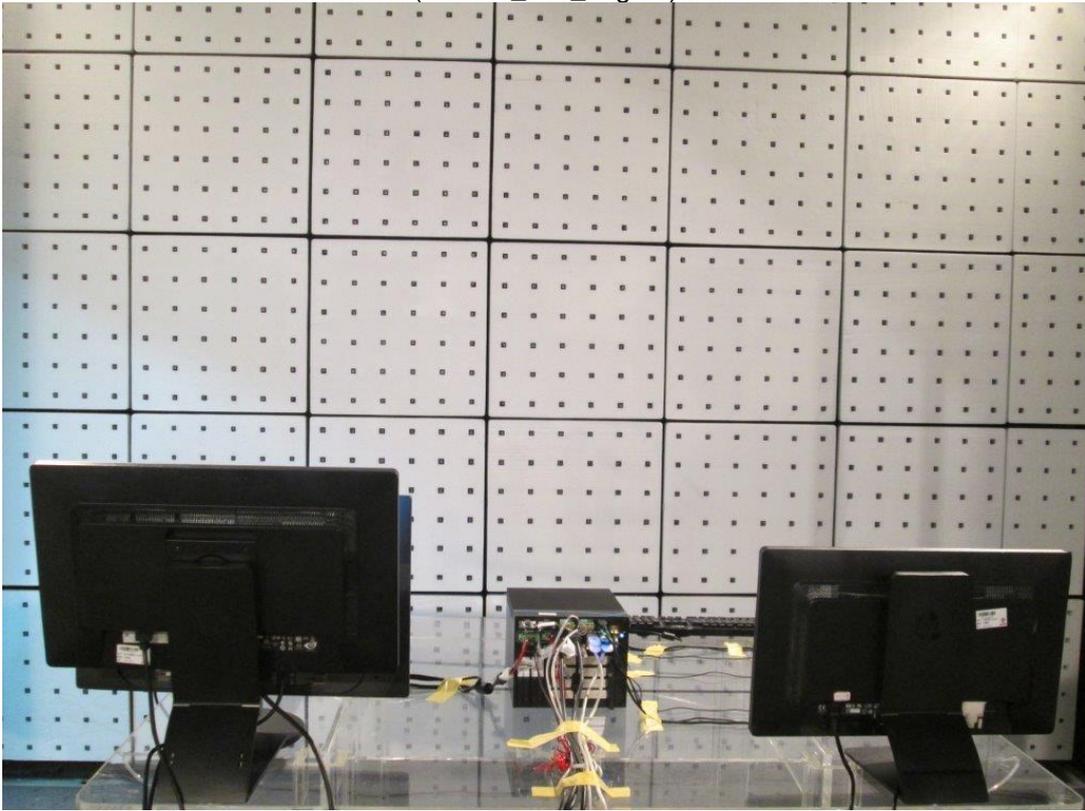
(Mode 1_0_degree)



(Mode 1_90_degree)



(Mode 1_180_degree)



(Mode 1_270_degree)

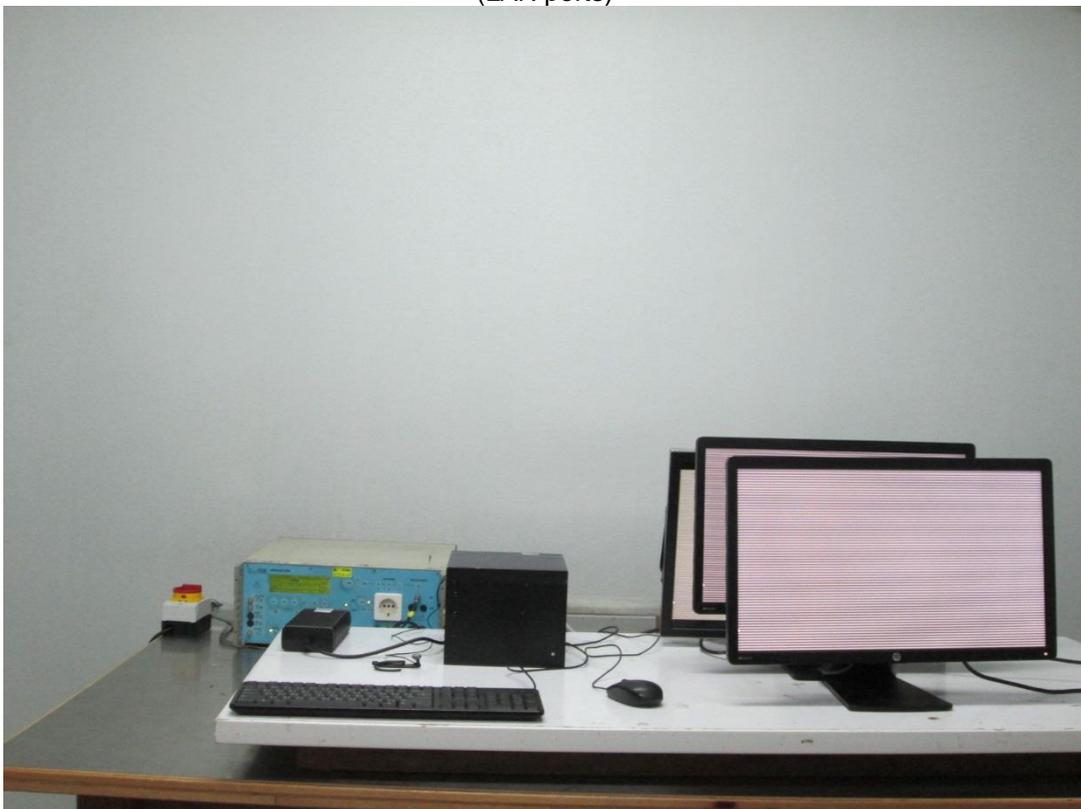


19.8 Electrical Fast Transient/Burst Immunity Test (EFT)

(AC ports)



(LAN ports)



19.9 Surge Immunity Test



19.10 Conducted Disturbances Induced by RF Fields (CS)

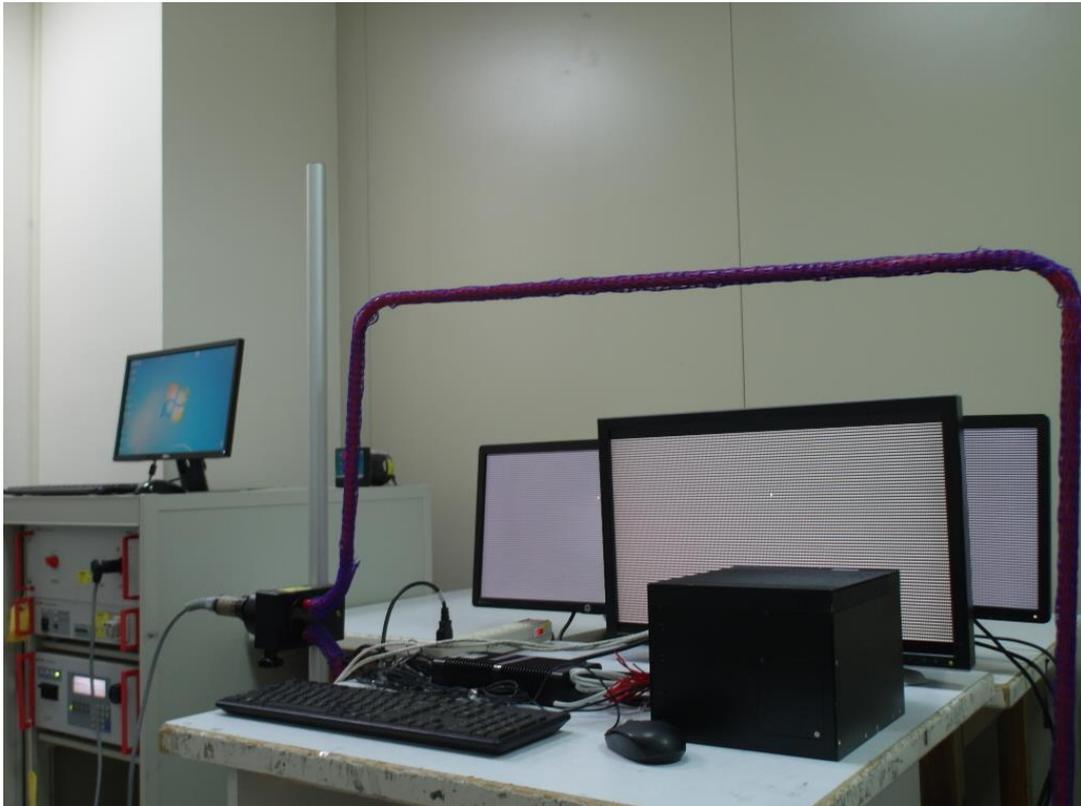
(AC ports)



(LAN ports)



19.11 Power Frequency Magnetic Field Immunity Test (PFMF)



19.12 Voltage Dips and Interruptions



Appendix – Information of the Testing Laboratories

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved according to ISO/IEC 17025.

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The address and road map of all our labs can be found in our web site also.

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